

Application de la modélisation par Réseaux Bayésiens à la sûreté de fonctionnement

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Présentation disponible sur HAL

<http://hal.archives-ouvertes.fr>

Manufacturing systems

**The objective is to define
maintenance / control strategy of the Equipment**

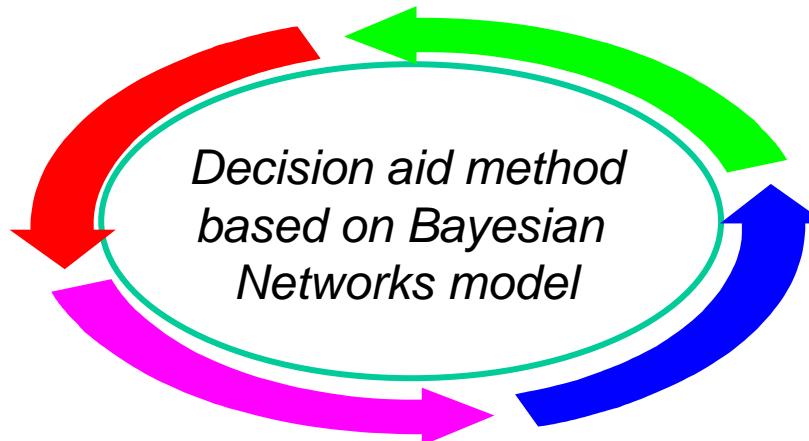
In regard to

organisational resources

financial resources

and technical: diagnosis, reliability and
performances of the system

Several types of strategies are available



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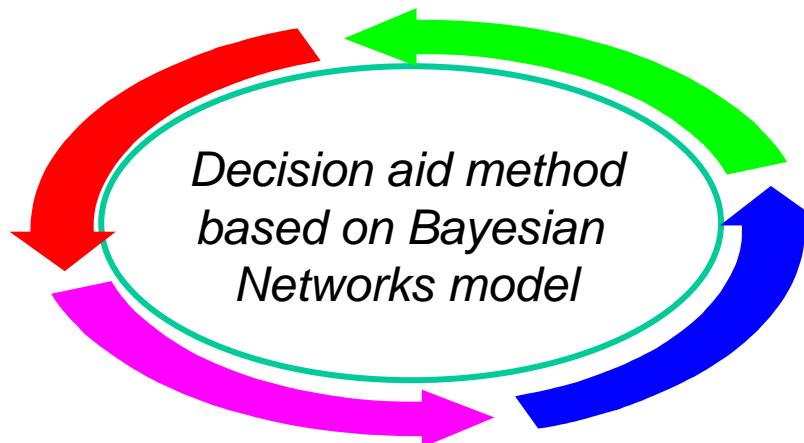
financial resources



and technical: diagnosis, reliability and
performances of the system



Several types of strategies are available



Outline

Bayesian Networks model in Reliability Analysis

Dynamic Bayesian Networks model in Reliability Analysis and Diagnosis

Bayesian Networks in Risk analysis of socio-technical systems

Conclusion

Bayesian Network model of component

Static Bayesian Networks

Discrete random variable →

X_1	up	down
	0.2	0.8
	↑	

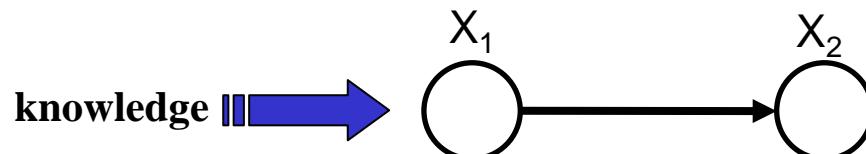
a priori distribution

variable states ←

$p(X_2|X_1)?$

	X_2	State 1	State 2	State 3
X_1	up	0.7	0.1	0.2
	down	0.1	0.6	0.3

Conditional Probability Table CPT



The marginal probability X_2 is computed as follows

$$p(X_2 = \text{State 1}) = p(X_2 = \text{State 1} | X_1 = \text{up}) \cdot p(X_1 = \text{up}) + p(X_2 = \text{State 1} | X_1 = \text{down}) \cdot p(X_1 = \text{down})$$

With the a priori knowledge

$$p(X_2 = \text{State 1}) = 0.7 \cdot 0.2 + 0.1 \cdot 0.8 = 0.22$$

Bayesian Network model of component

Static Bayesian Networks

Discrete random variable →

X ₁	up	down
	0.2	0.8

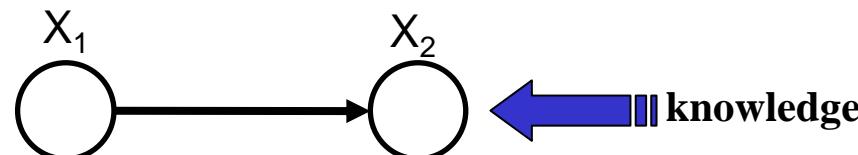
variable states ←

a priori distribution ↑

p(X₂|X₁)?

	X ₂	State 1	State 2	State 3
X ₁				
up	0.7	0.1	0.2	
down	0.1	0.6	0.3	

Conditional Probability Table CPT



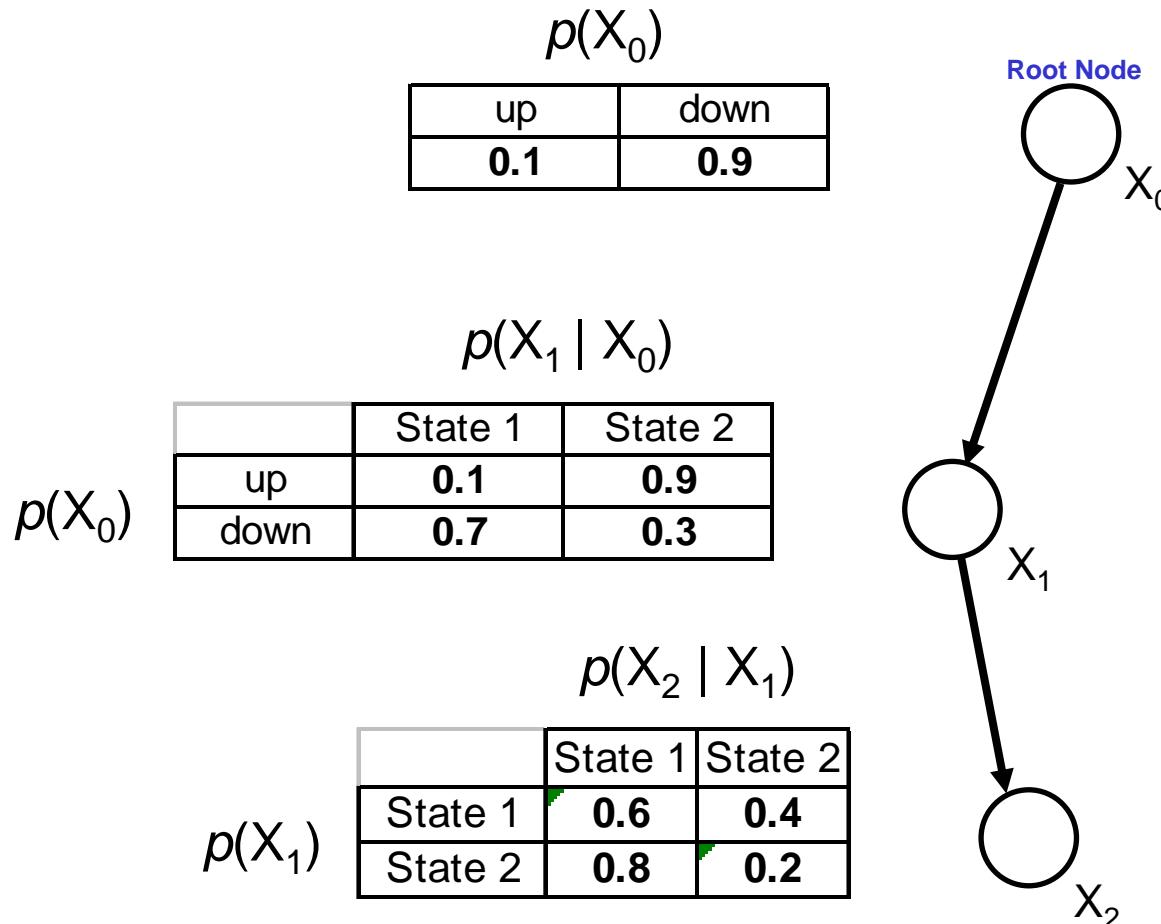
The marginal probability X₁ is computed with the Bayes theorem as follows

$$p(X_1 = \text{up} | X_2 = \text{State 1}) = \frac{p(X_1 = \text{up}) \cdot p(X_2 = \text{State 1} | X_1 = \text{up})}{p(X_2 = \text{State 1})}$$

The propagation of this probability through the BN is based on **inference** algorithms

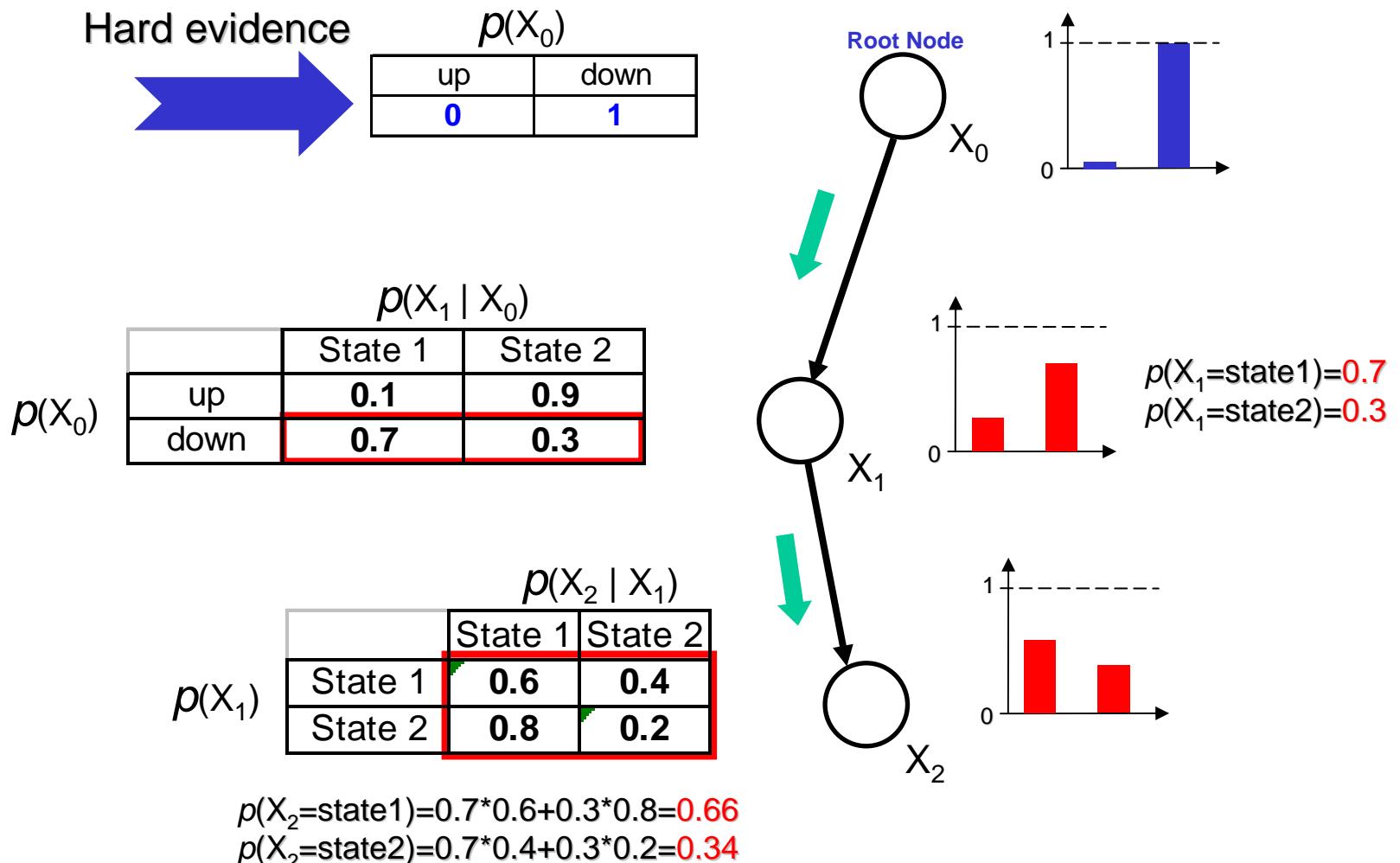
Bayesian Network model of component

Static Bayesian Networks



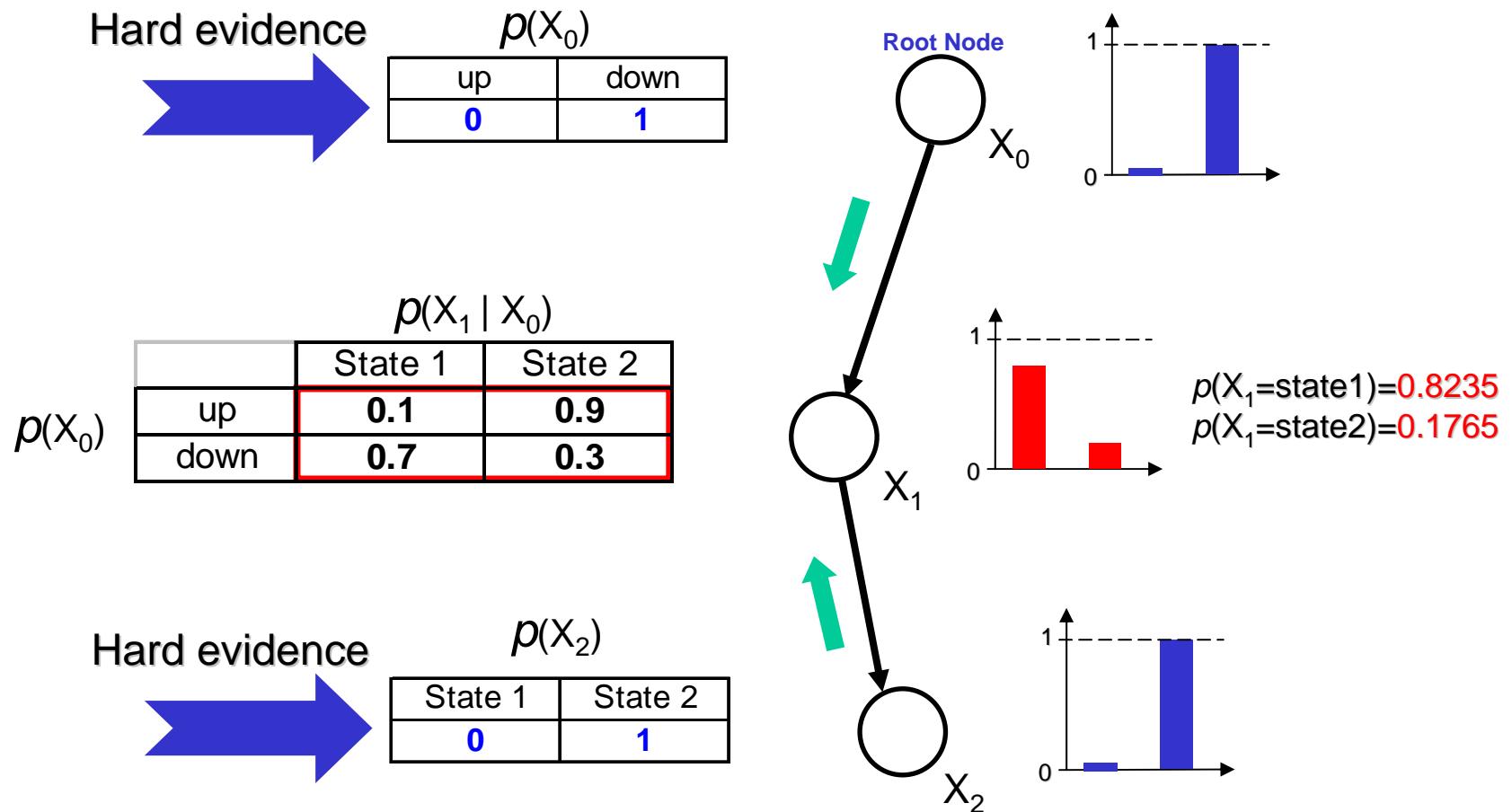
Bayesian Network model of component

Static Bayesian Networks



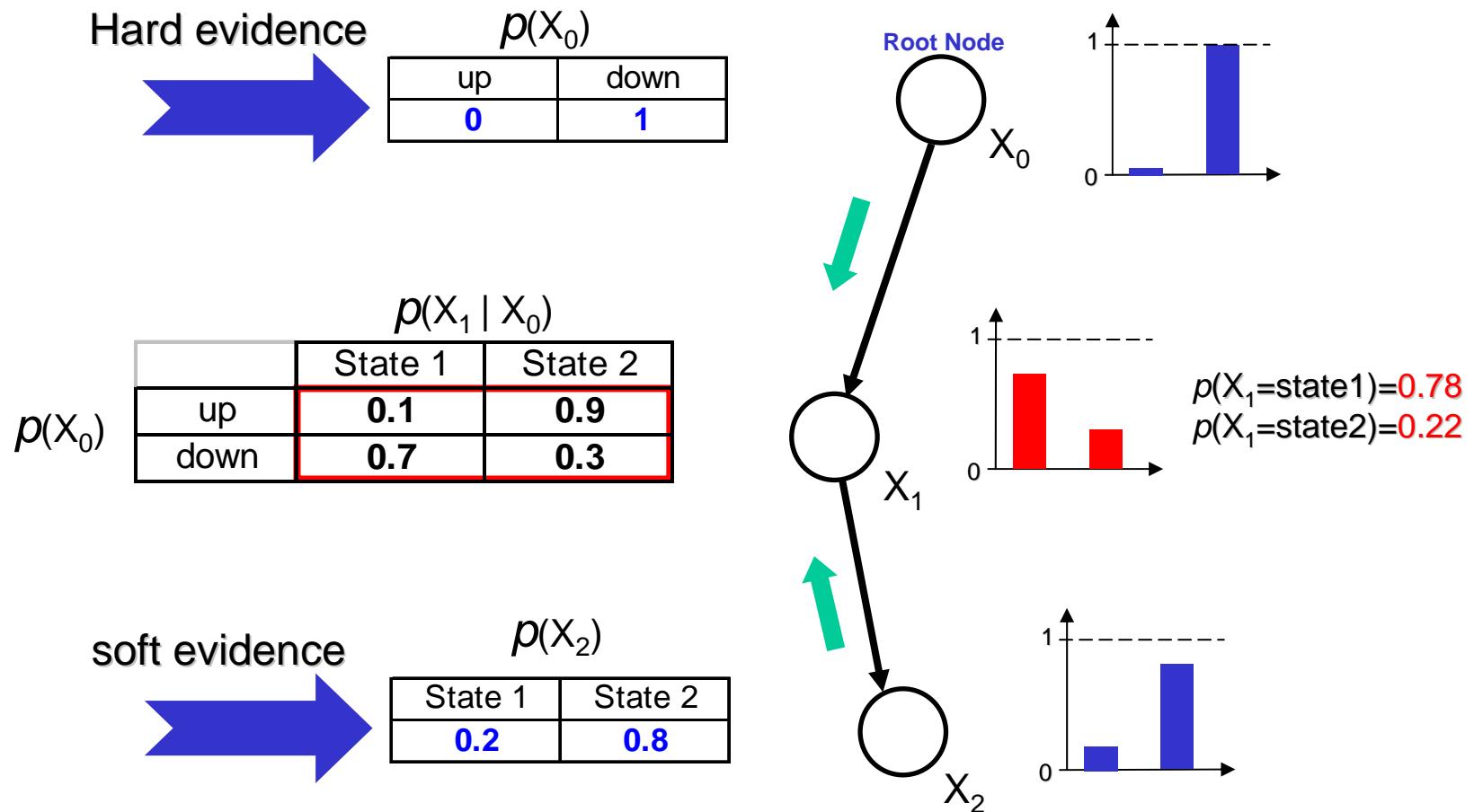
Bayesian Network model of component

Static Bayesian Networks



Bayesian Network model of component

Static Bayesian Networks



Bayesian Network model of component

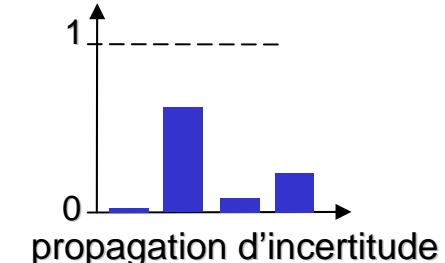
Static Bayesian Networks

Distribution des effets d'une défaillance sur plusieurs modes de défaillance ou de fonctionnement

Définition de la structure des TPC de FE		Fonction i affectée par la défaillance du composant			
		Fonctionnement de la fonction i	Mode de défaillance 1 de la fonction i	...	Mode de défaillance n de la fonction n
Composant	Etat de fonctionnement			...	
	défaillance 1	0.1	0.6	...	0.2

	défaillance n			...	

Distribution des effets de la défaillance 1 sur le fonctionnement de la fonction i



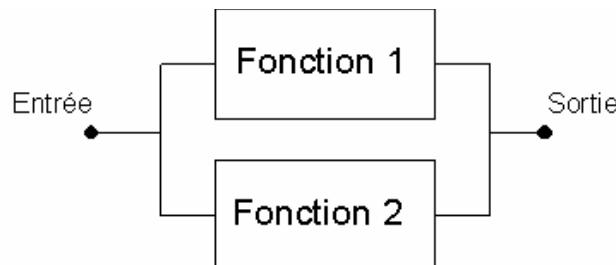
Apprentissage sur Historiques de GMAO

Bayesian Network model of system

Static Bayesian Networks

Modèle de fiabilité d'un **système** à 2 composants (les variables sont à 2 états : OK et HS)

A) Architecture parallèle



Réseau Bayésien

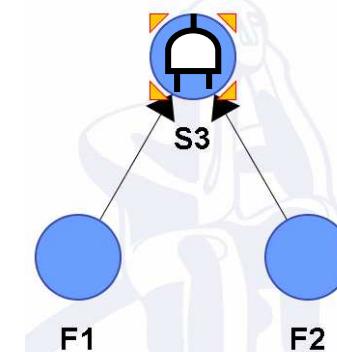
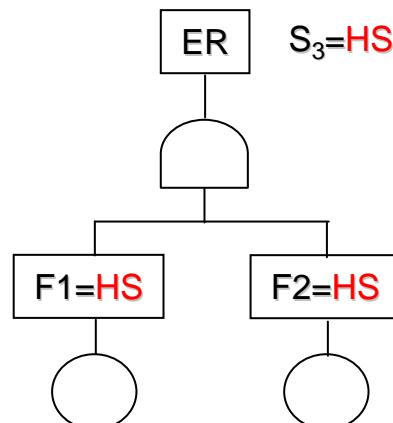
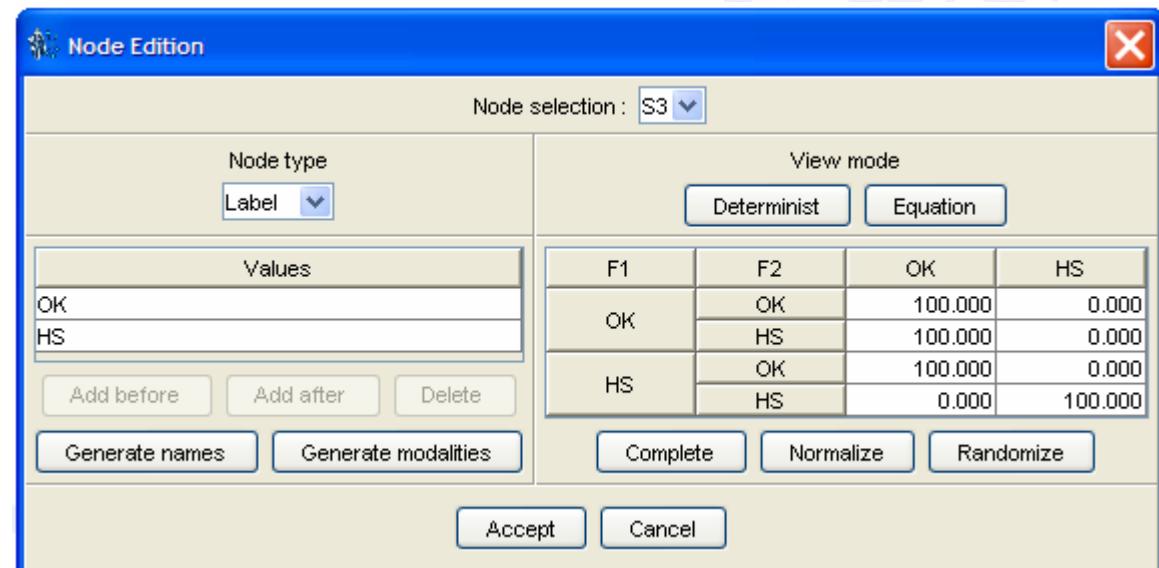


Diagramme de Fiabilité



Arbre de Défaillances



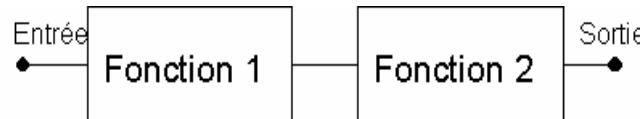
$$p(S)_{DF} = 1 - \prod_{i=1}^2 p(F_i = HS) = p(S_3 = OK)_{RB}$$

Bayesian Network model of system

Static Bayesian Networks

Modèle de fiabilité d'un **système** à 2 composants (les variables sont à 2 états : OK et HS)

B) Architecture série



Réseau Bayésien

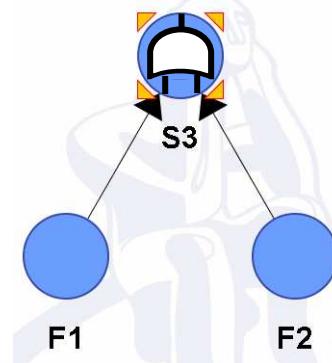
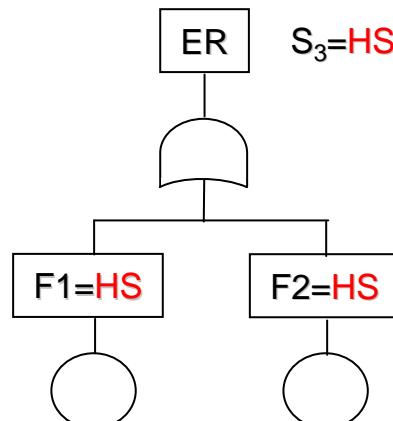
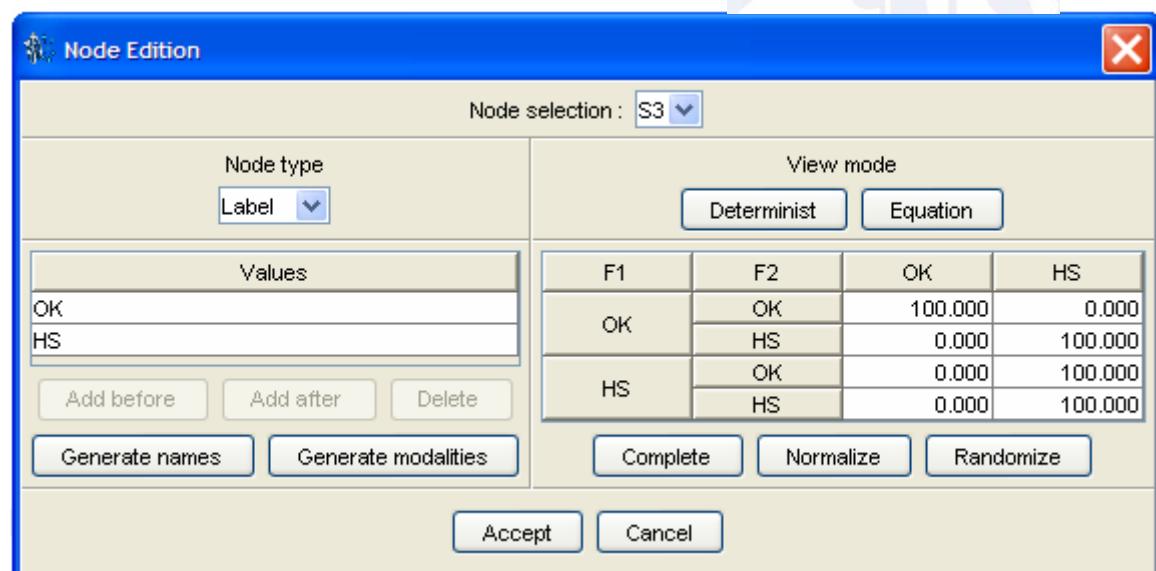


Diagramme de Fiabilité



Arbre de Défaillances

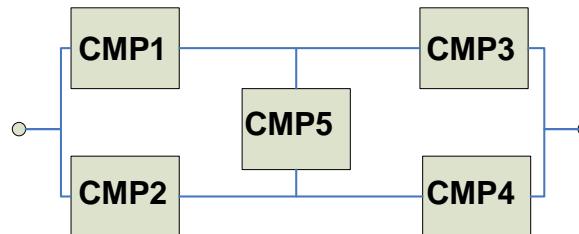


$$p(S)_{DF} = \prod_{i=1}^2 p(F_i = OK) = p(S_3 = OK)_{RB}$$

Bayesian Network model of system

Static Bayesian Networks

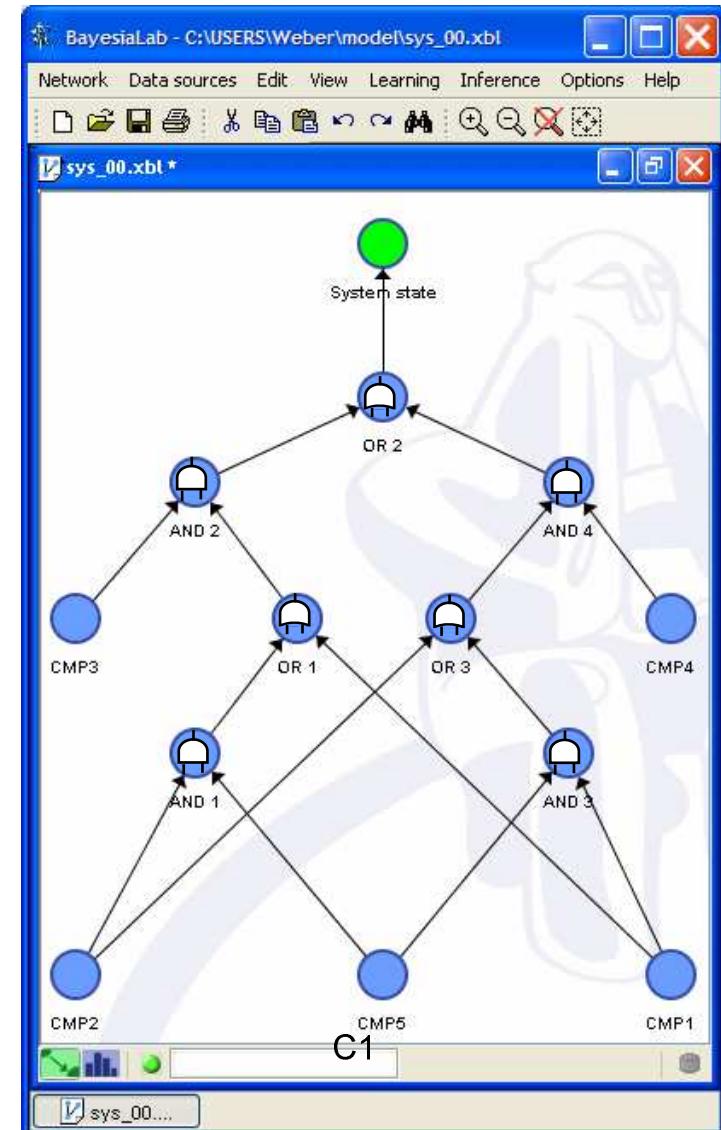
Modèle de fiabilité d'un système complexe



La représentation sous la forme d'un **arbre** de défaillances n'est pas adaptée car CMP1, CMP2 et CMP5 ne peuvent pas être factorisés

$$ER = \text{CMP3.CMP4} \\ + \text{CMP1.CMP2} \\ + \text{CMP1.CMP5.CMP4} \\ + \text{CMP2.CMP5.CMP3}$$

En RB le modèle est structuré sous la forme d'un **graphe** et les calculs sont réalisés par inférence

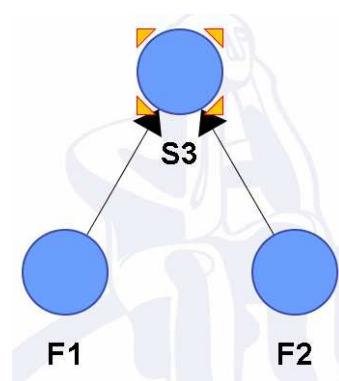


Bayesian Network model of system

Static Multimodal Bayesian Networks

Dans un cadre de modélisation réaliste, les composants **peuvent subir plusieurs défaillances ce qui** conduit à plusieurs modes de défaillance ! Le Modèle de fiabilité de ce type de système ne peut plus reposer sur un arbre de défaillances (car le modèle n'est plus booléen)

Codage directe d'équation complexe dans la TPC avec F2 multimodale



The diagram shows a Bayesian Network node labeled S3, which has two parents labeled F1 and F2. Each parent has a yellow arrow pointing to node S3.

Node Edition dialog box:

- Node selection :** S3
- Node type :** Label
- View mode :** Determinist (selected), Equation
- Values :** OK, HS
- F1 (True) :**

F2	OK	HS
OK	100.000	0.000
HS1	100.000	0.000
HS2	0.000	100.000
- F1 (False) :**

F2	OK	HS
OK	0.000	100.000
HS1	0.000	100.000
HS2	0.000	100.000
- Buttons :** Add before, Add after, Delete, Generate names, Generate modalities, Complete, Normalize, Randomize, Accept, Cancel

Prise en compte des dépendances

Bayesian Network model of system

Static Multimodal Bayesian Networks

Structuration du modèle sous la forme d'un graphe avec dépendance des branches et F2 multimodale

Node Edition

Node selection : etat 1

Node type Label	Determinist	Equation		
Values				
OK	F1	F2	OK	HS
HS	OK	OK	100.000	0.000
	HS	HS1	100.000	0.000
		HS2	100.000	0.000
	OK	OK	100.000	0.000
	HS	HS1	0.000	100.000
		HS2	100.000	0.000

Add before Add after Delete
Generate names Generate modalities
Complete Normalize Randomize
Accept Cancel

Node Edition

Node selection : etat 2

Node type Label	Determinist	Equation		
Values				
OK	F1	F2	OK	HS
HS	OK	OK	100.000	0.000
	HS	HS1	100.000	0.000
		HS2	0.000	100.000
	OK	OK	0.000	100.000
	HS	HS1	0.000	100.000
		HS2	0.000	100.000

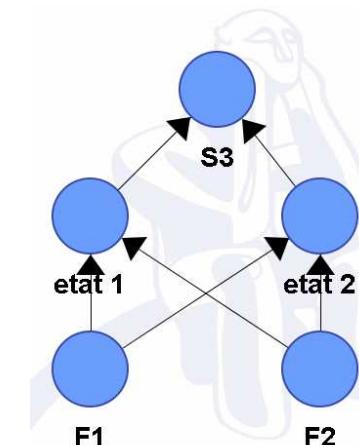
Add before Add after Delete
Generate names Generate modalities
Complete Normalize Randomize
Accept Cancel

Node Edition

Node selection : S3

Node type Label	Determinist	Equation		
Values				
OK	etat 1	etat 2	OK	HS
HS	OK	OK	100.000	0.000
	HS	HS	0.000	100.000
	OK	OK	0.000	100.000
	HS	HS	0.000	100.000

Add before Add after Delete
Generate names Generate modalities
Complete Normalize Randomize
Accept Cancel



Dynamic Bayesian Networks in System Reliability Analysis

Problem statement

System reliability

$R_S(t)$ The probability that no failure occurred during the interval $[0, t]$

$\lambda_S(t)$ Failure rate **of the system** at time t

$$R_S(t) = \exp\left(-\int_0^t \lambda_S(t) dt\right)$$

When the system is composed with several components

Then the failure rate $\lambda_n(t)$ **is defined for each component**

The probability that a failure occurred between t and $t+dt$ is approximated by

$$p_n = \lambda_n(t) \cdot dt$$

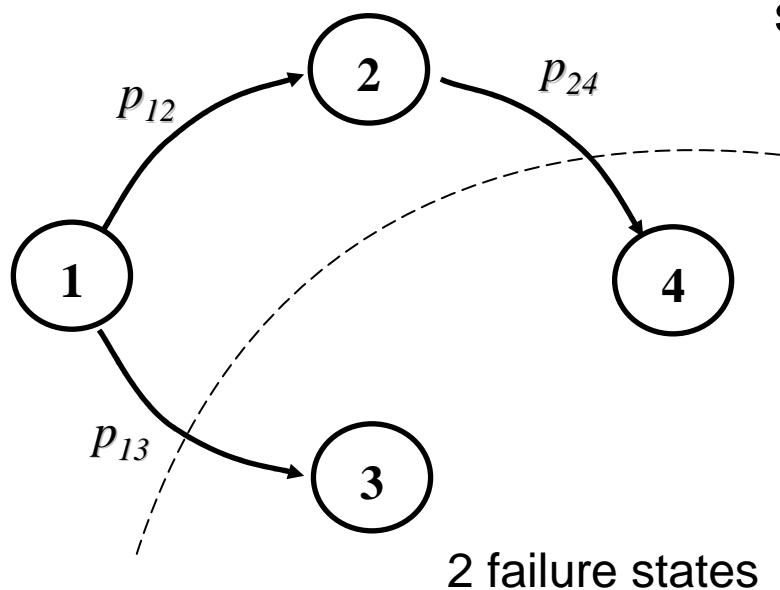
Markov Chain is a classic solution to model this sort of system Reliability when failure rates are constant

Problem statement

Example of application to reliability

Operational states and failure states represent a system up or down

operational states



The reliability computation needs the solution of a differential equation system

$$\left[\frac{dX_t}{dt} \right]^T = X_t \cdot (\mathbf{I} - \mathbf{P}_{MC})$$

$$R_S(t) = \sum_{i \in \{1, 2\}} p(X_t = s_i)$$

Problem statement

**Unfortunately Markov Process
are not enough sufficient to model real systems**

Therefore Markov Process are extended to model more realistic problem as

-  Degradation results in parameters are time-variant (SMP)
 [Phase Type Distribution](#)
-  Exogenous constraint results in a conditional behaviour
 [Markov Switching Model](#)
-  Moreover in practice the complexity of the system leads to a combinatorial explosion of states resulting in a Markov Chain with a great size
 Then **Dynamic Bayesian Networks (DBN)** are proposed as a more synthetic model to represent these **stochastic processes**

Bayesian Network model of component

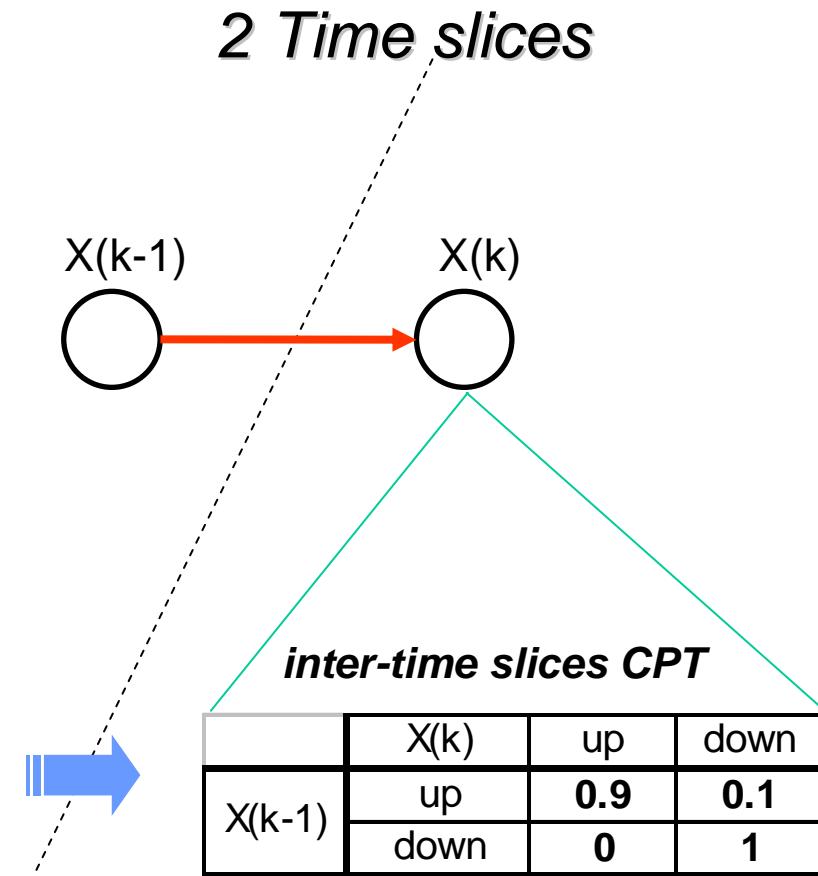
Dynamic Bayesian Networks

A Dynamic Bayesian Network (DBN) is a BN extension including temporal dimensionality

Red arcs represent the temporal dependence between *different* time slices

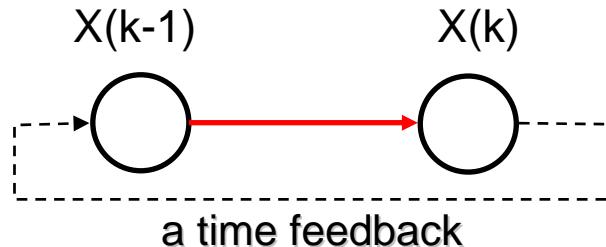
Defining these impacts as *transition-probabilities* between the states of the variable X at time (k-1) and (k)

The DBN compute the behaviour of the probability distribution over the stats of the variable X



Bayesian Network model of component

Dynamic Bayesian Networks



inter-time slices CPT

	$X(k)$	up	down
$X(k-1)$	up	0.9	0.1
	down	0	1

Starting from an observed situation at time $k=0$, the probability distribution over the states at the next time is computed

using successive inferences

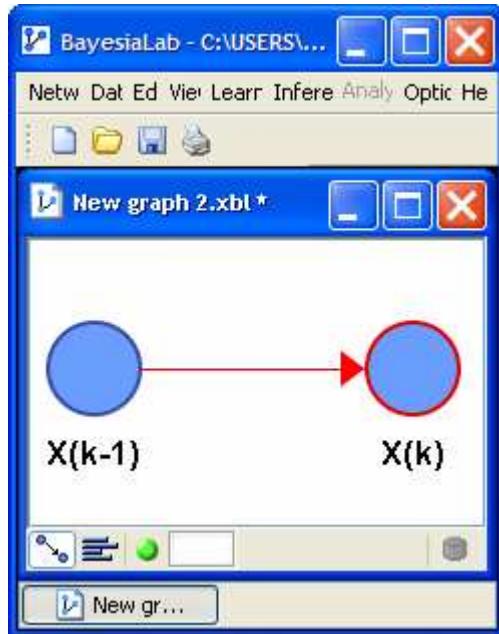
(the variable X_k is considered as the new observation of X_{k-1} through a time feedback)



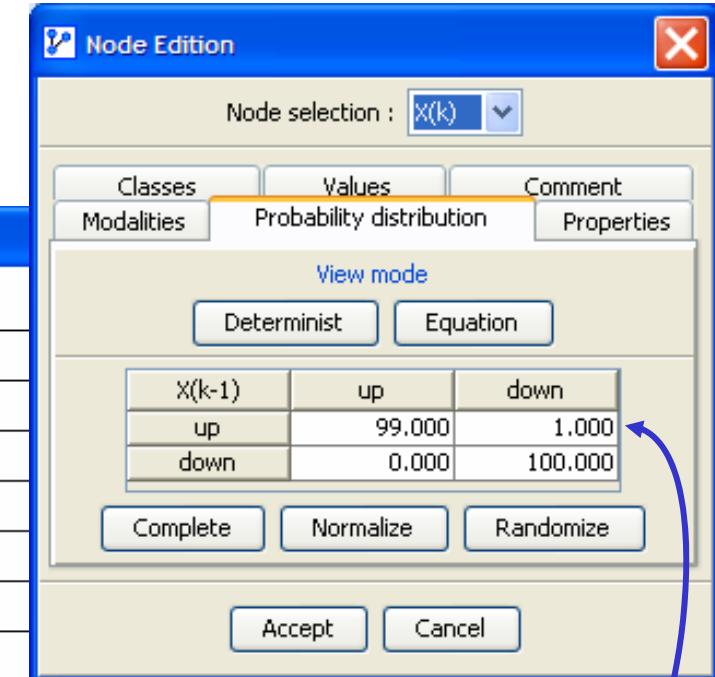
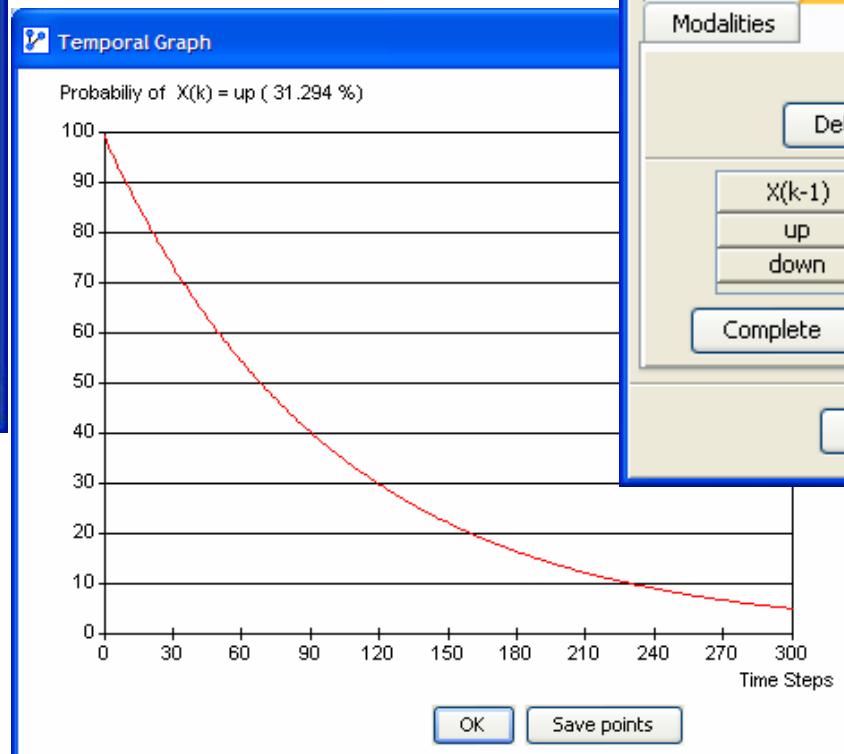
Then the *inter-time slices CPT* is a Markov Chain model

Application in Reliability of component

Dynamic Bayesian Network / Markov Chain model



$$R_n(k) = P(X(k) = \text{up})$$



$$p_{12} \cong \lambda_n \Delta t$$

$$\lambda_n = \frac{1}{MTTF}$$



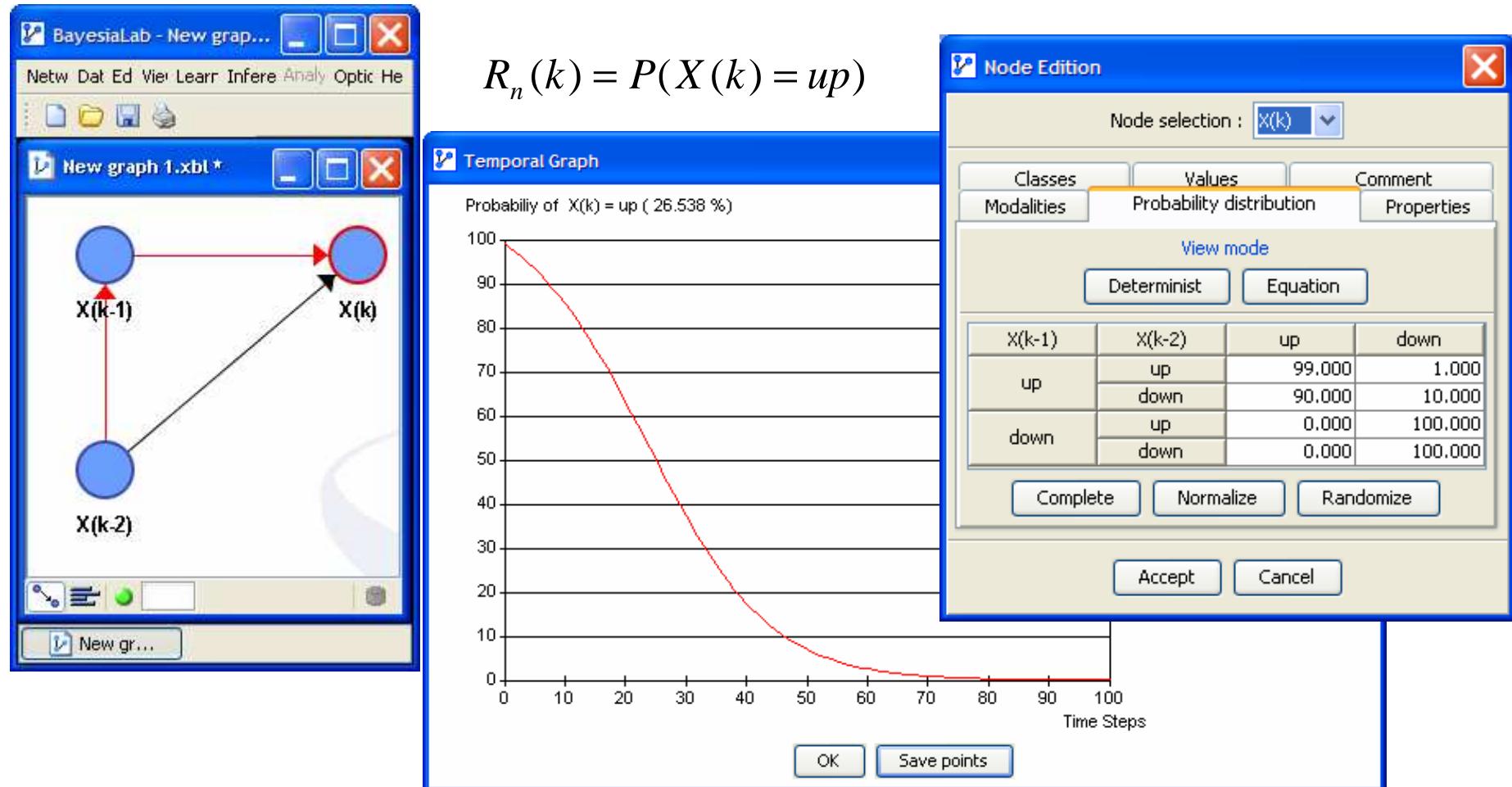
Then the reliability is given by simulation

WEBER P., JOUFFE L. Reliability modelling with Dynamic Bayesian Networks. 5th IFAC Symposium on Fault Detection, Supervision and Safety of Technical Processes (SAFEPROCESS'03), Washington, D.C., USA, 9-11 juin, 2003.

	$X(k)$	up	down
$X(k-1)$	up	$1 - p_{12}$	p_{12}
	down	0	1

Application in Reliability of component

Dynamic Bayesian Network / Markov model of order n

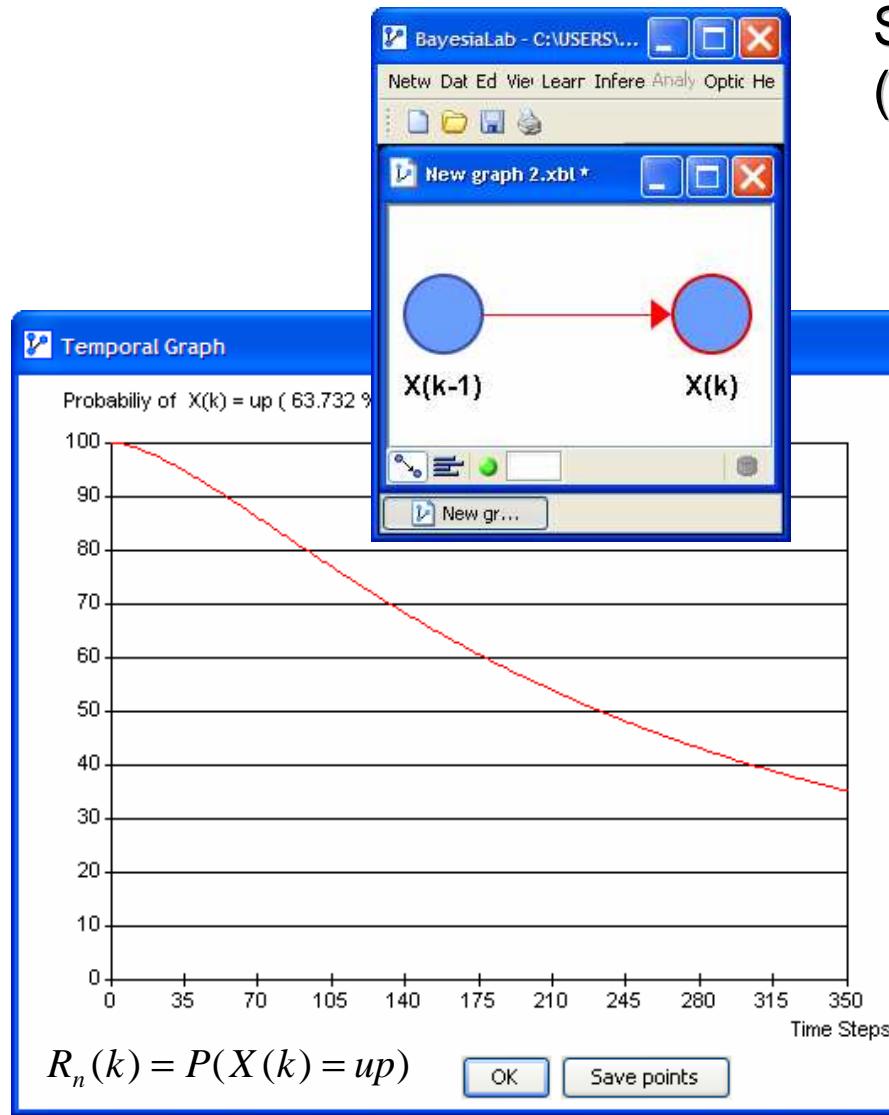


→ Open problem: to learn the parameter !

BEN SALEM A., BOUILLAUT L., AKNIN P., WEBER P. Dynamic Bayesian Networks for classification of rail defects. IEEE 4th International Conference on Intelligent Systems Design and Applications (ISDA 2004), Budapest, Hungary, August 26-28, 2004.

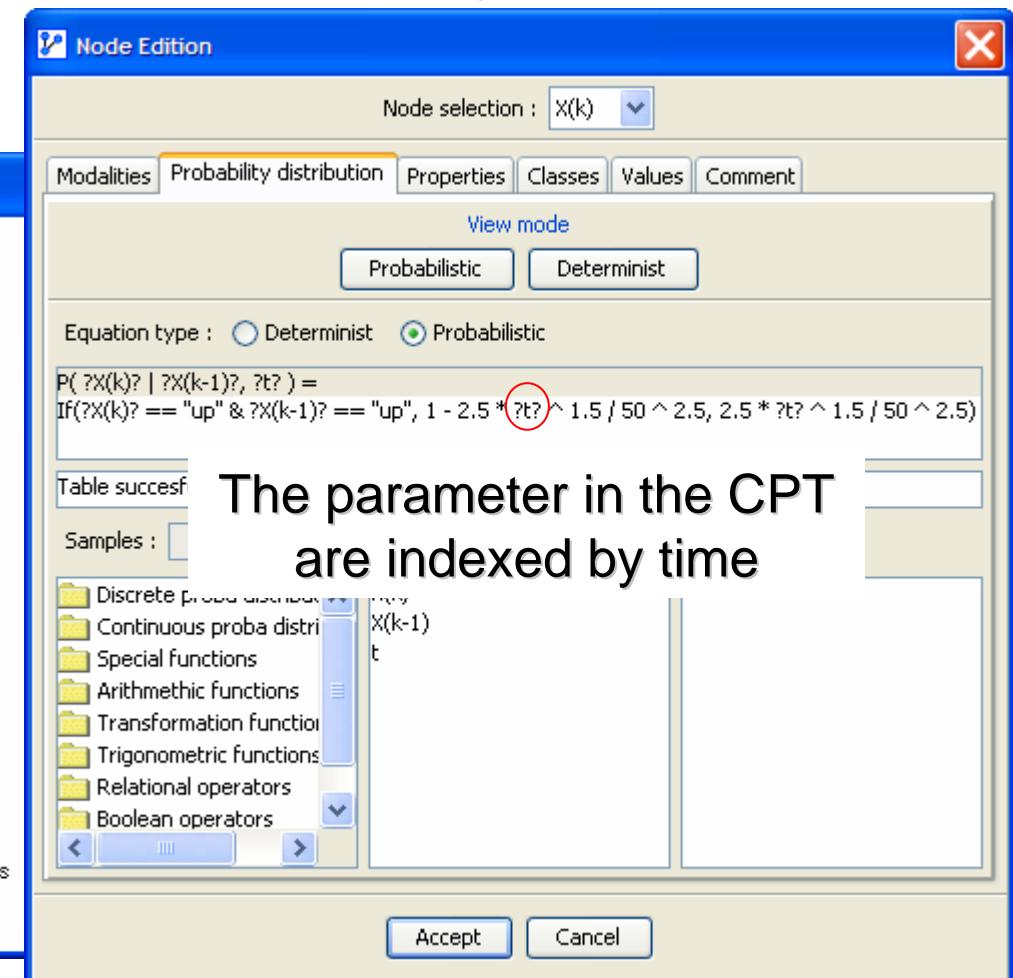
Application in Reliability of component

Dynamic Bayesian Network / semi Markov Process



System with time variant failure rate
(weibull)

$$\lambda_1(t) = \frac{\beta \cdot t^{\beta-1}}{\eta^\beta}, \beta = 2.5, \eta = 50$$



Application in Reliability of component

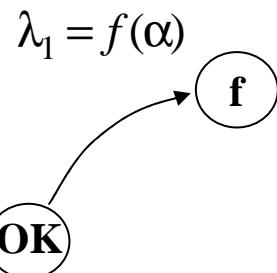
Dynamic Bayesian Network / Markov Switching Model

A process changes its behavior according to the state of exogenous constraints representing functioning conditions, maintenance events ...

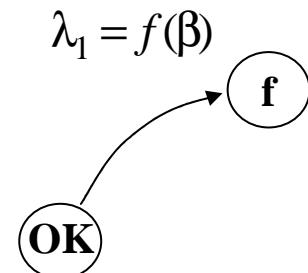
The exogenous constraint is represented by an external variable U_k

Markov Switching Model

$$U(k)=\alpha$$



$$U(k)=\beta$$



Analytic solution

$$\left[\frac{dX_t}{dt} \right]^T = X_t \cdot (\mathbf{I} - \mathbf{P}_{MC})$$

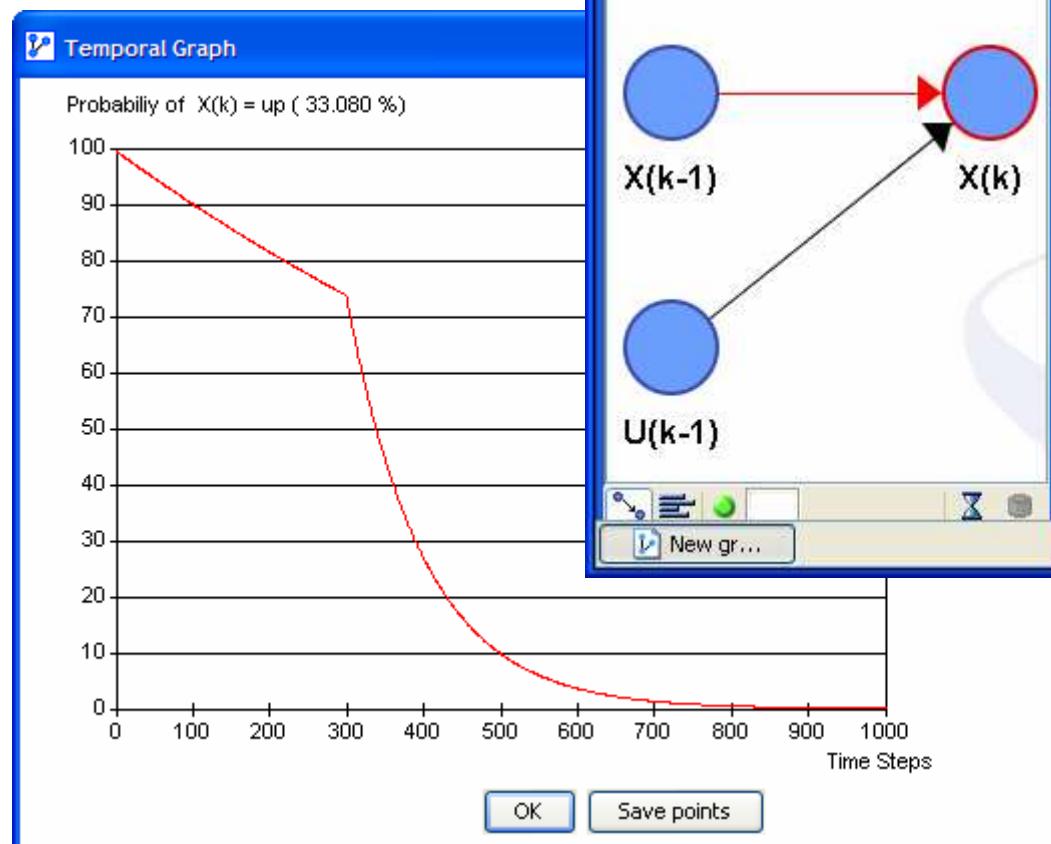


Discret simulation

Application in Reliability of component

Dynamic Bayesian Network / Markov Switching Model

$$R_n(k) = P(X(k) = \text{up})$$



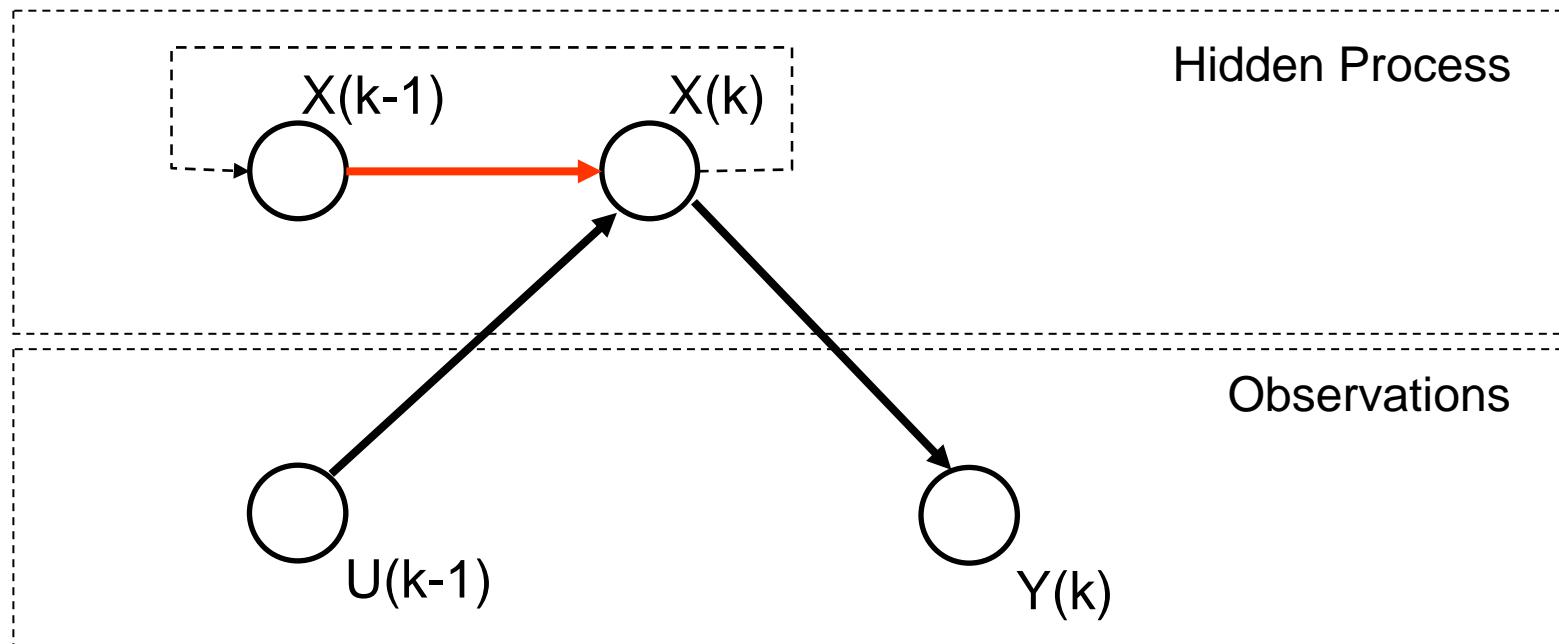
The 'Node Edition' dialog is shown in more detail. It has tabs for 'Modalities' (selected), 'Values', 'Comment', and 'Properties'. Under 'View mode', it offers 'Determinist' and 'Equation' options. The 'Values' tab displays the same probability distribution table as the 'Node Edition' dialog in the previous figure. At the bottom are buttons for 'Accept', 'Cancel', 'Complete', 'Normalize', and 'Randomize'.

U(k-1)	X(k-1)	up	down
A	up	99.900	0.100
	down	0.000	100.000
B	up	99.000	1.000
	down	0.000	100.000

Application in Reliability of component

Dynamic Bayesian Network / IOHMM

In the previous slides the stochastic processes are supposed to be completely observable. In practice this is seldom the reality because the physical degradations of a component result in a change of its state which is observed only through a variation in the component functionality.

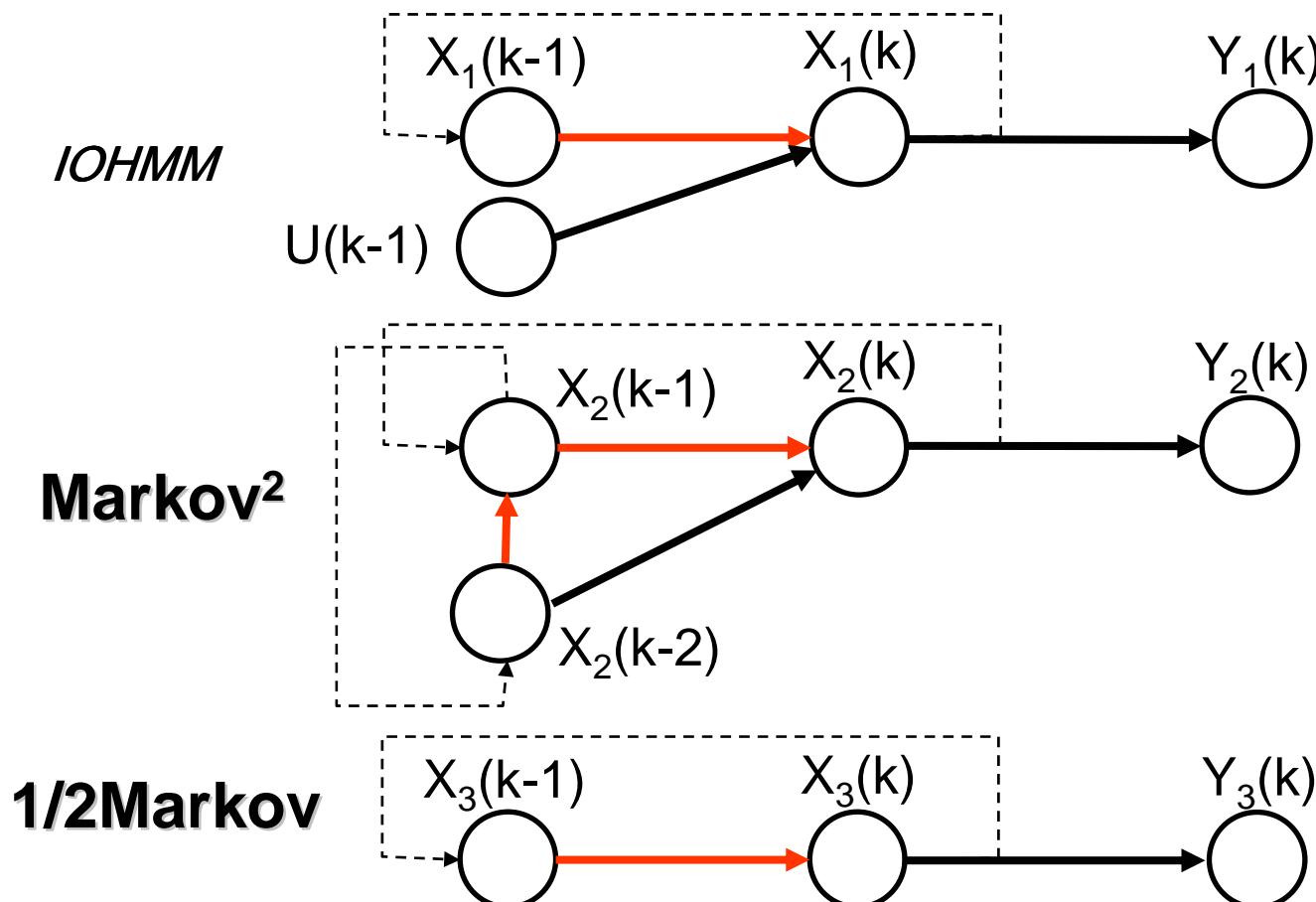


Parameter estimation needs many data !!!

Application in Reliability of system

Dynamic Bayesian Network - Factorized MC model

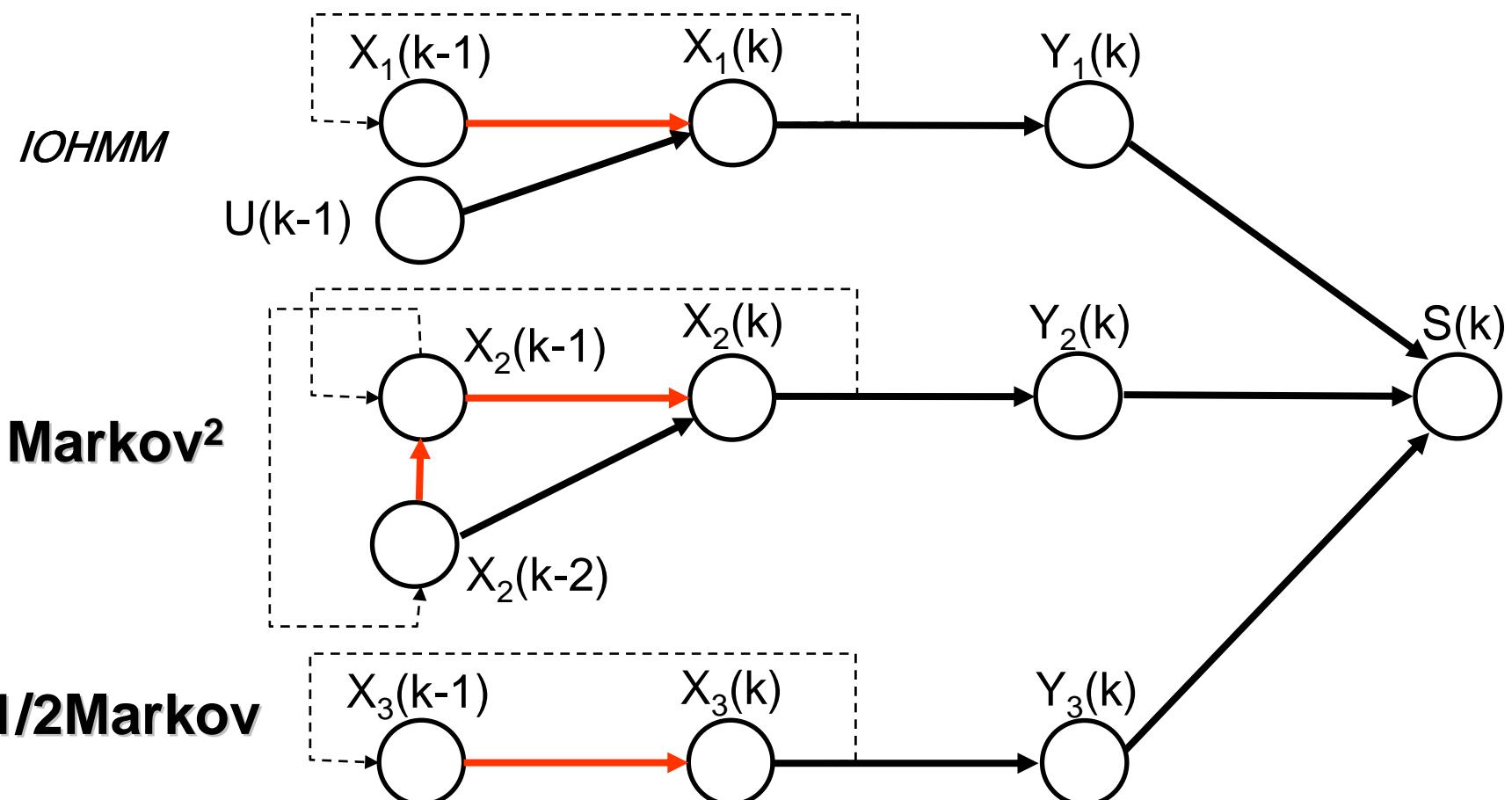
The reliability of component can be modelled as a DBN as presented before
If the components are independent the DBN allows to merge the models
through a factorised form



Application in Reliability of system

Dynamic Bayesian Network - Factorized MC model

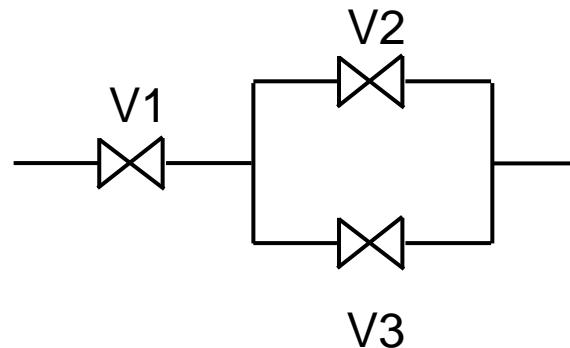
The reliability of component can be modelled as a DBN as presented before
If the components are independent the DBN allows to merge the models
through a factorised form



Application 1 in Reliability

Dynamic Bayesian Network - Factorized MC model

The method is applied to a classical example of reliability analysis.



Three valves are used to distribute or not a fluid.

Every valves have two failure modes

- remains closed (RC)
- remains opened (RO)

WEBER P., JOUFFE L. Reliability modelling with Dynamic Bayesian Networks. 5th IFAC Symposium on Fault Detection, Supervision and Safety of Technical Processes (SAFEPROCESS'03), Washington, D.C., USA, 9-11 juin, 2003.

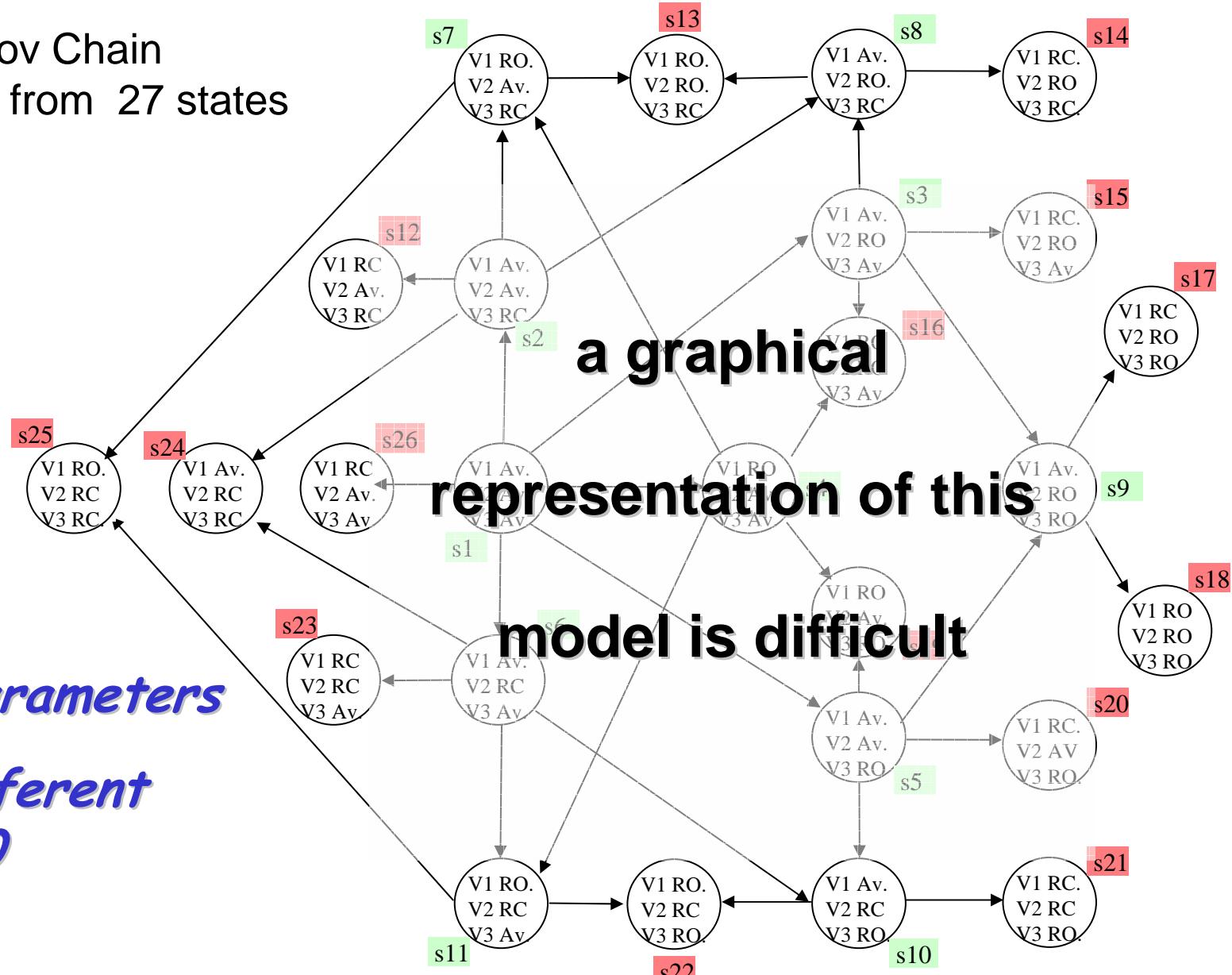
Application 1

Markov Chain

The Markov Chain
is defined from 27 states

729 parameters
*75 different
from 0*

**a graphical
representation of this
model is difficult**



Application 1 in Reliability

Dynamic Bayesian Network - Factorized MC model

the nodes

- 6 nodes are described
the 3 valves
- 3 nodes are described
the system state

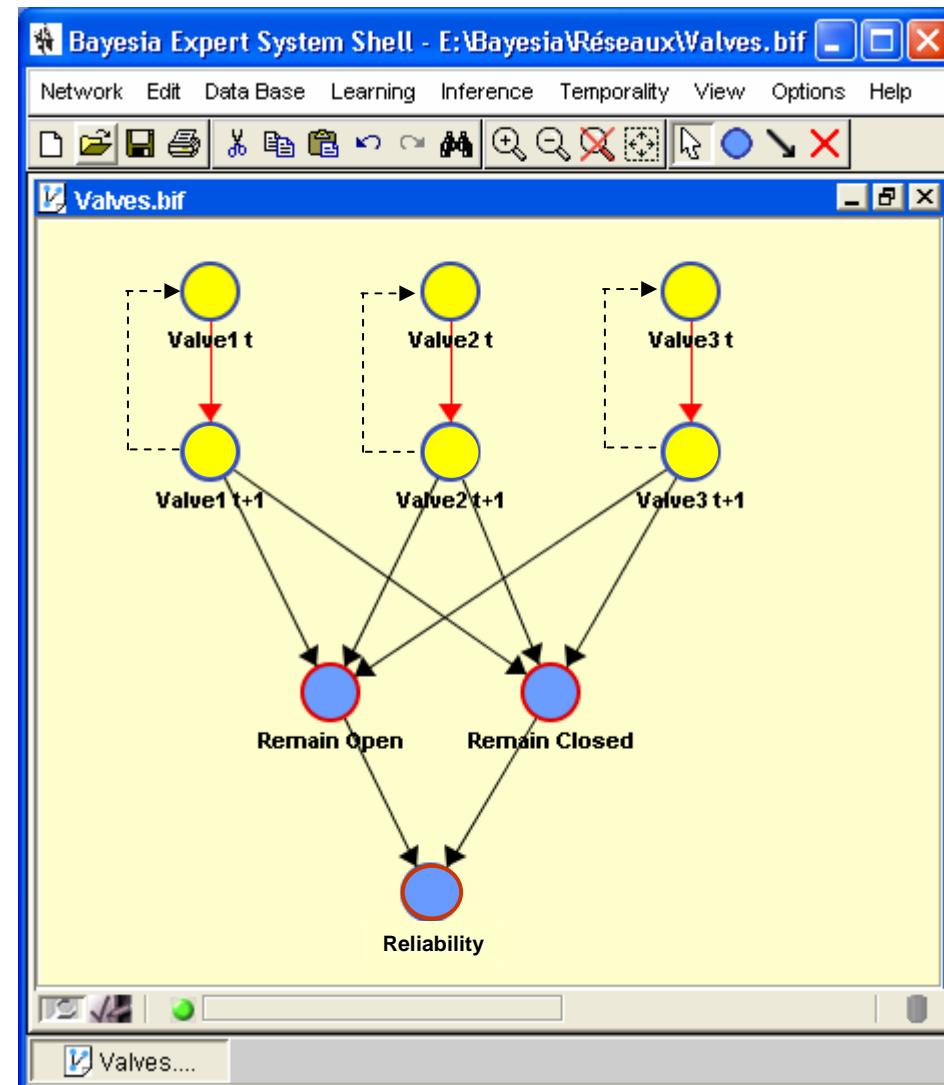
the CPTs

- 3 small MC
- and the logic of the failures propagation

143 parameters

73 different from 0

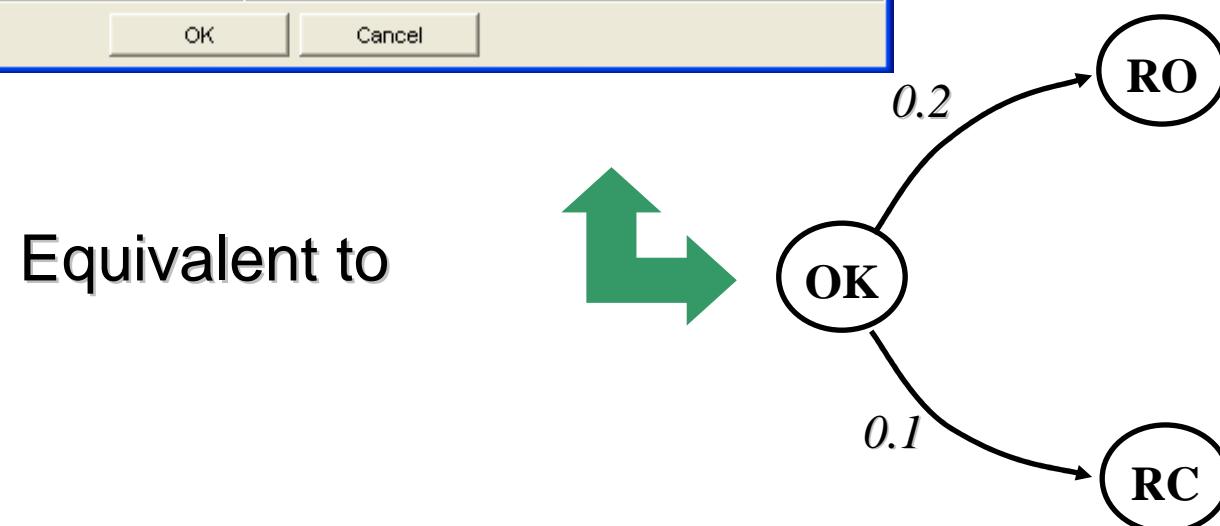
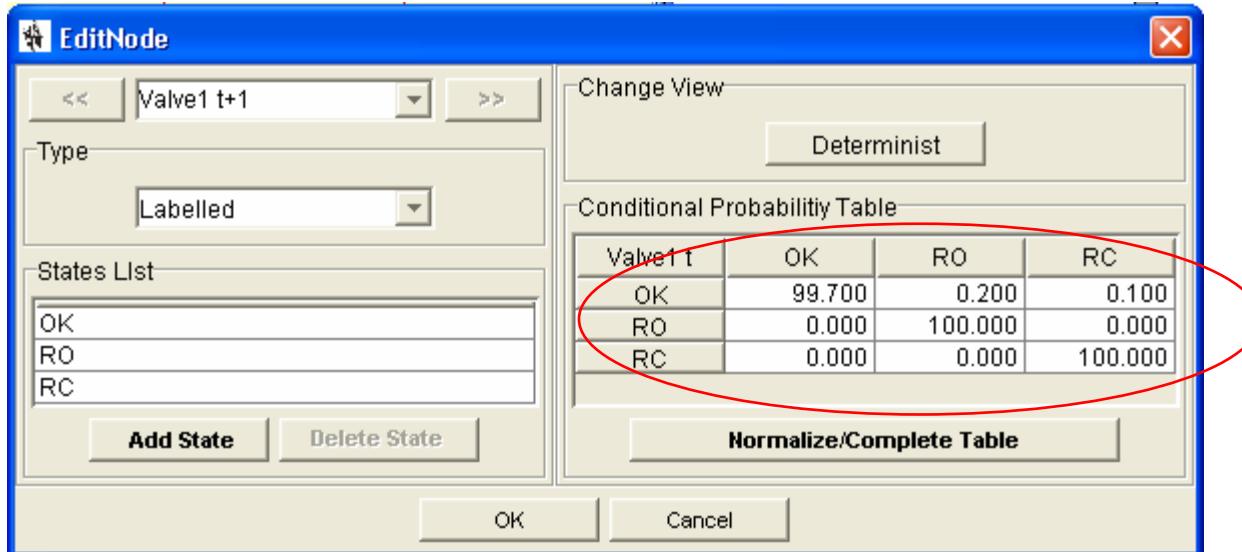
58 parameters are equal to 1



Application 1 in Reliability

Dynamic Bayesian Network - Factorized MC model

The inter time slices CPT represents a small MC

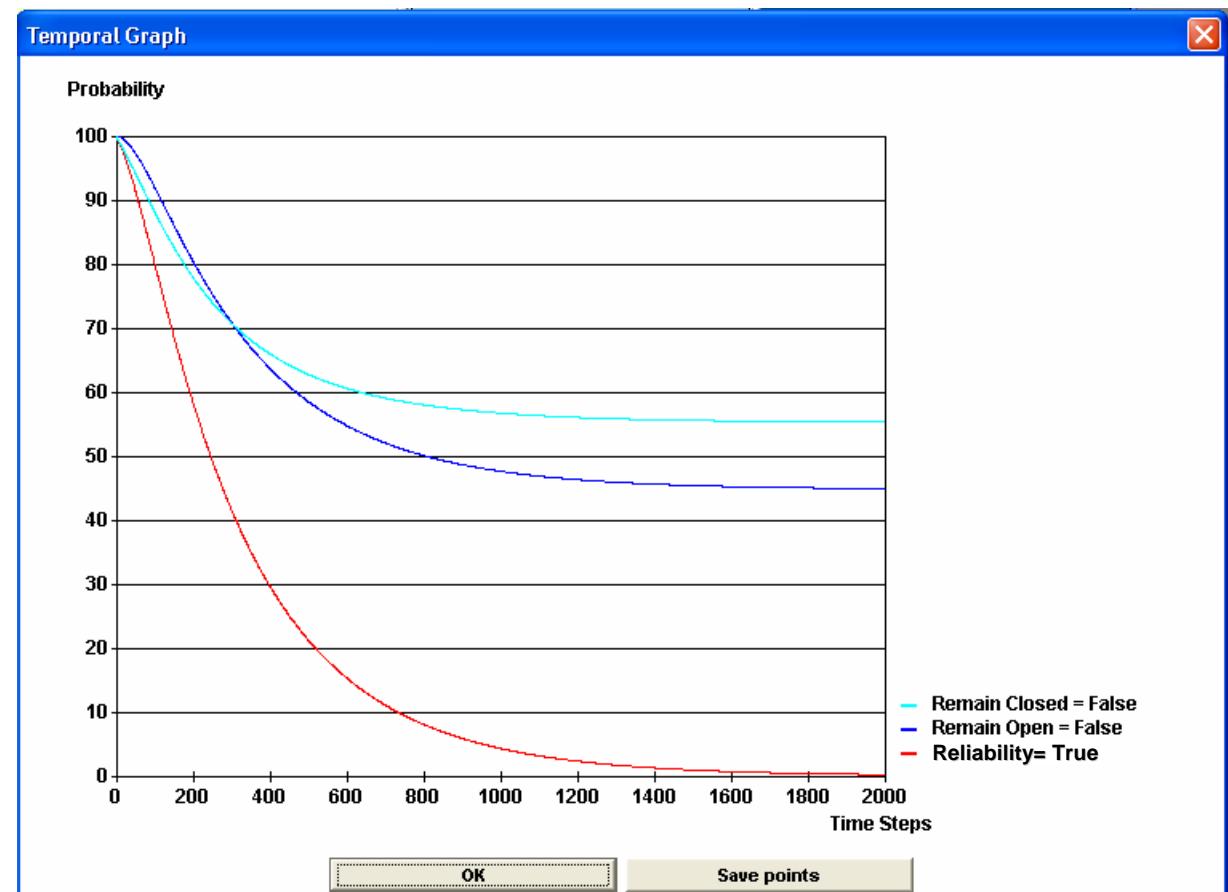


Application 1 in Reliability

The results after successive inferences

The behavior of the probability representing

- The System Remains Close (light blue)
- The System Remains Open (blue)
- The System Reliability (red) $R_s(t)$



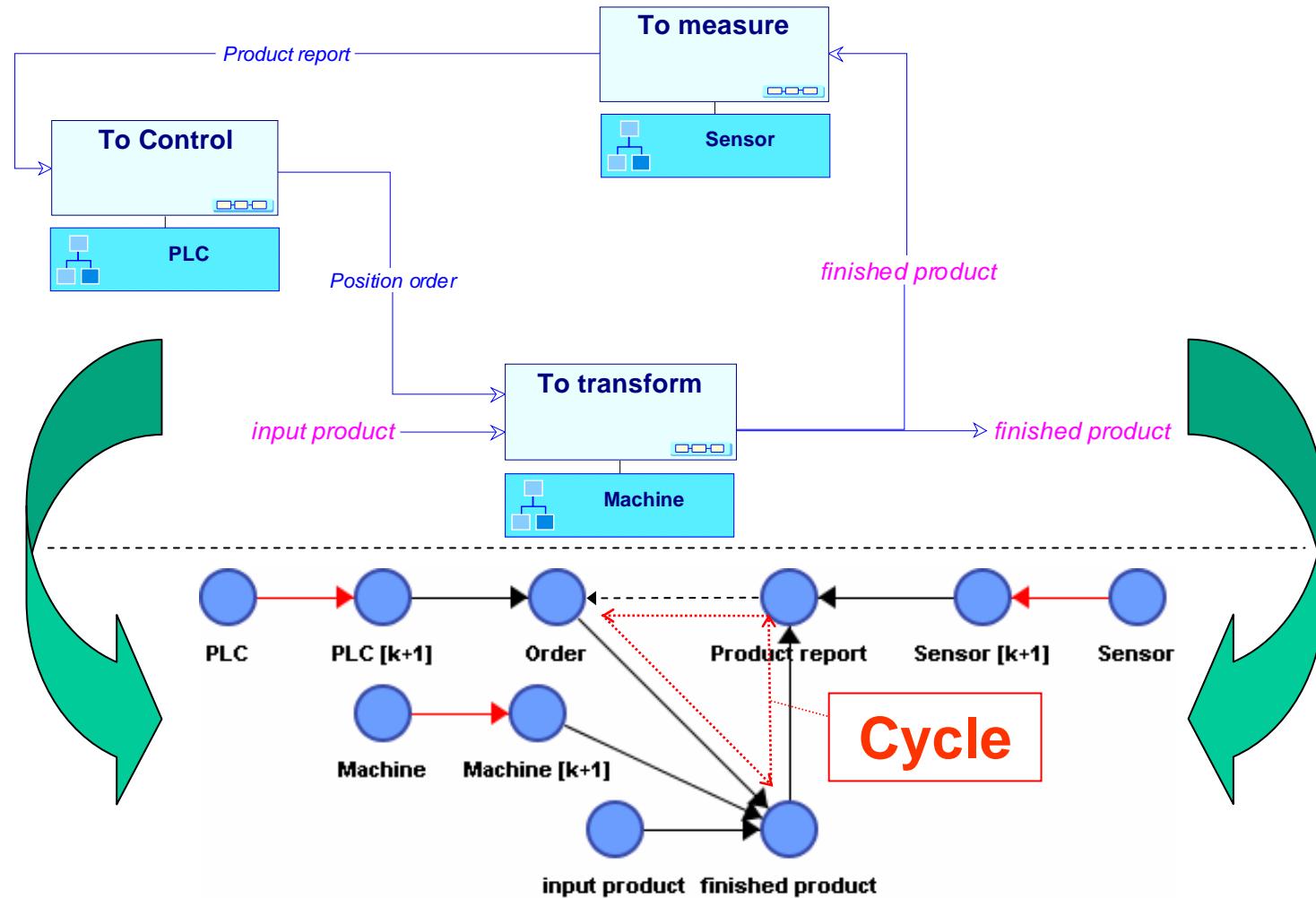
Process modelling approach in real application

- Methodology
 - Process and flow based approach
 - Functional/Dysfunctional reasoning
 - Hierarchical structure
 - Elaboration of the probabilistic network
 - Formalism: BN/DBN
 - Generic rules to transform the process model into a probabilistic one

But the Bayesian Network (BN)
needs Acyclic structure

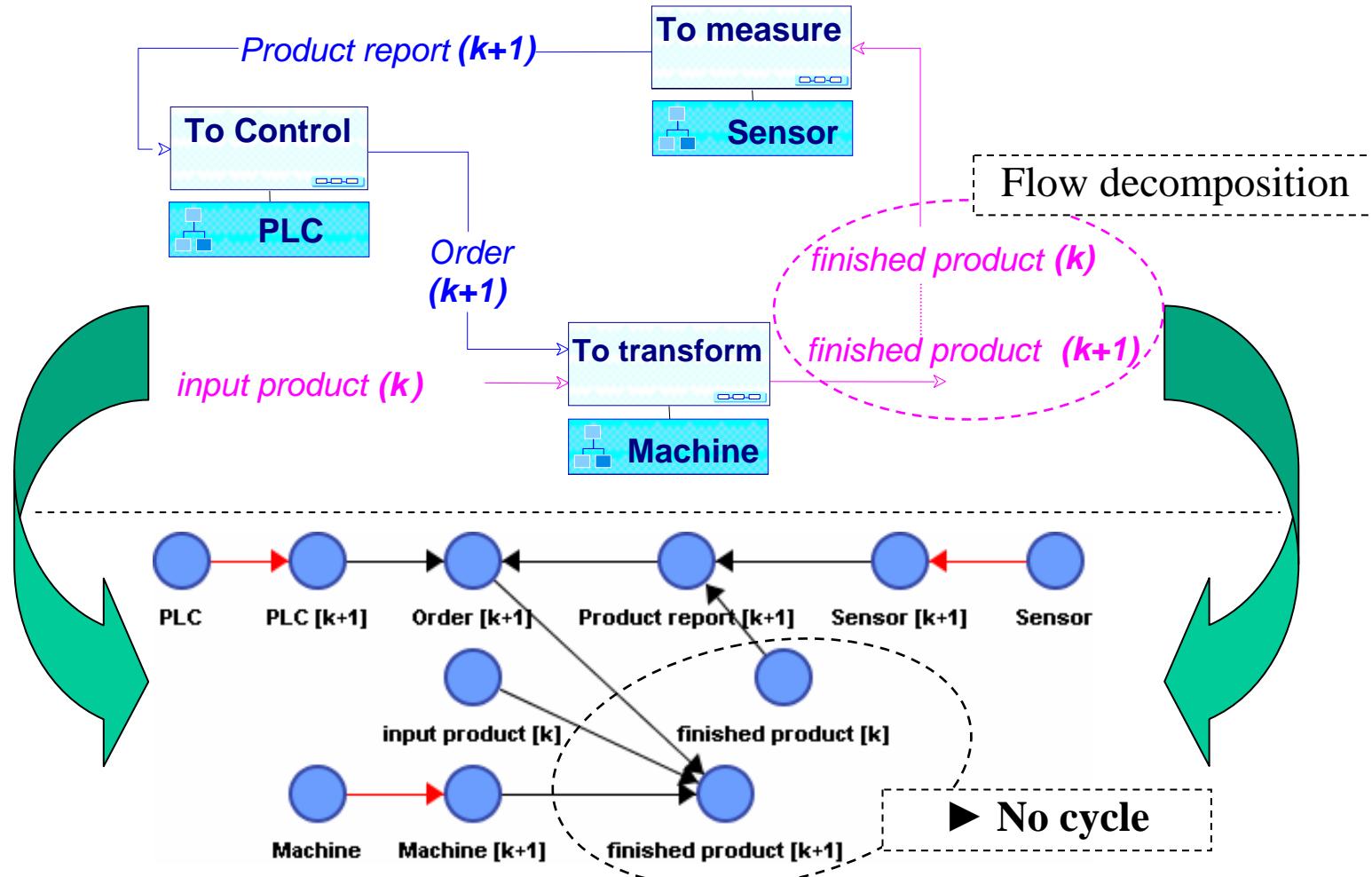
Probabilistic network development (2)

The cycle problem



Probabilistic network development (2)

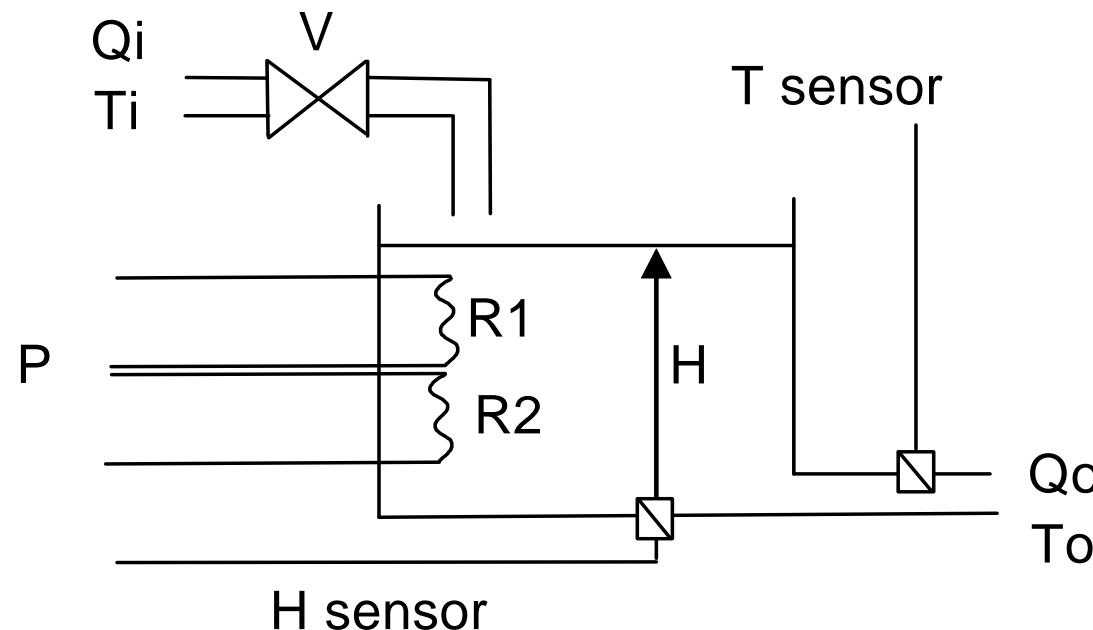
The translation with specification



Application 2 in Reliability

Dynamic Bayesian Network - Factorized MC model

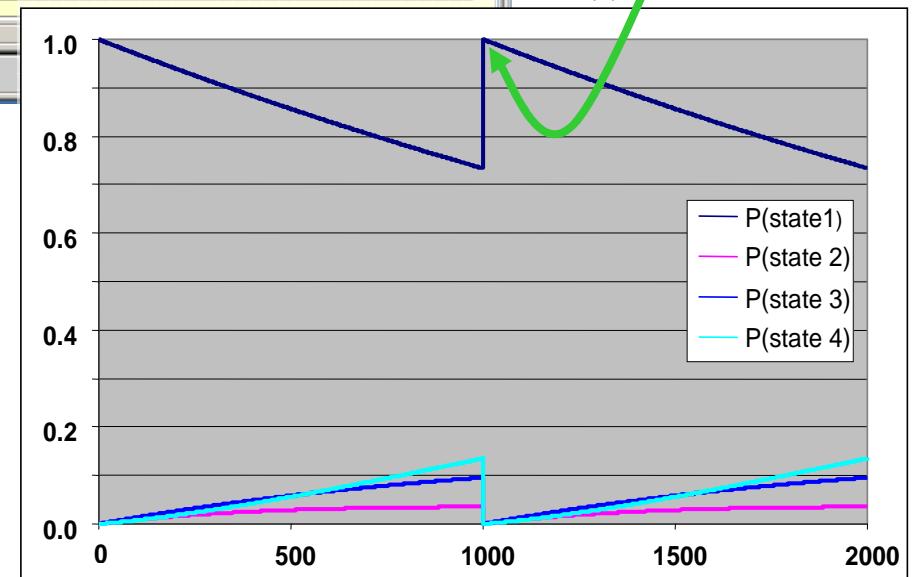
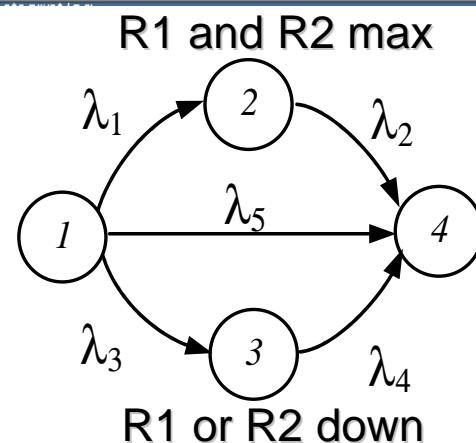
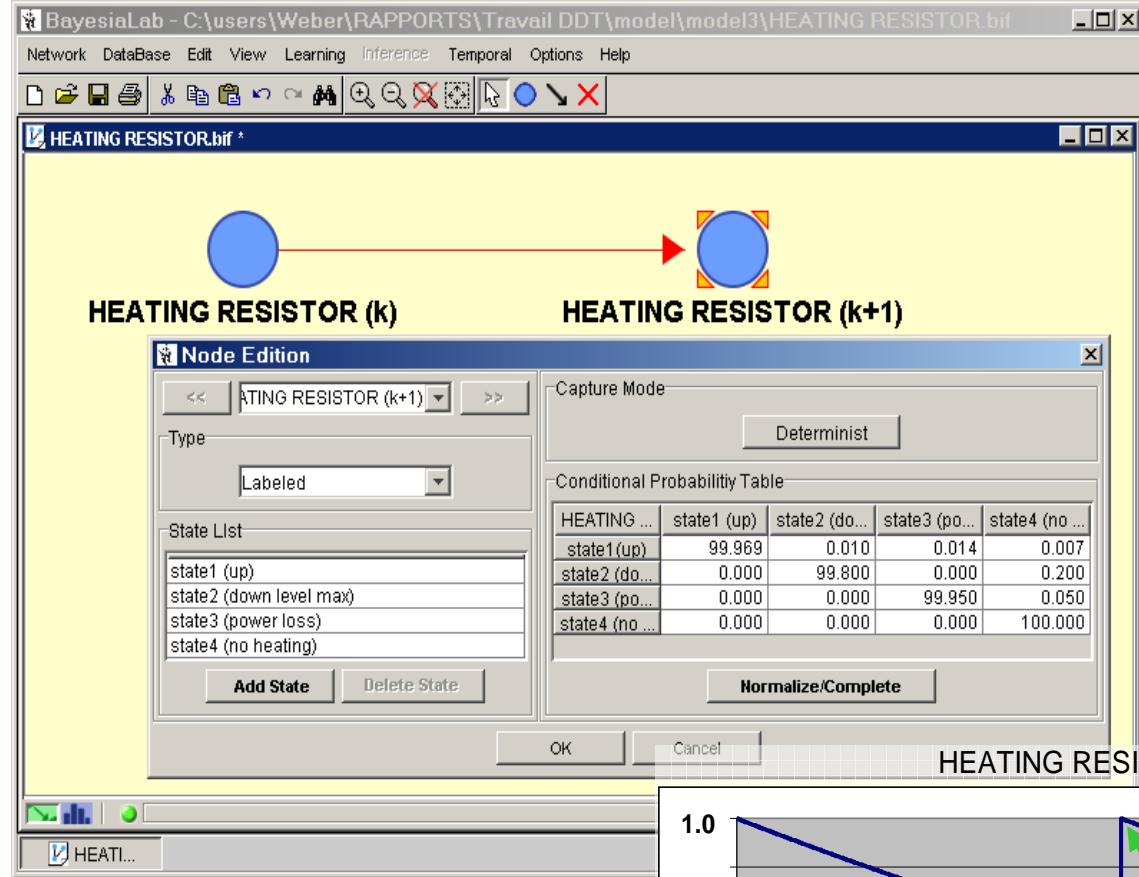
Water heater (Physical process)



WEBER P., JOUFFE L., Complex system reliability modelling with Dynamic Object Oriented Bayesian Networks (DOOBN). Reliability Engineering and System Safety, Volume 91, Issue 2, February 2006, Pages 149-162 (Selected Papers Presented at QUALITA 2003).

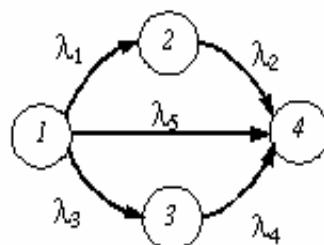
MULLER A., WEBER P., BEN SALEM A. Process model-based Dynamic Bayesian Networks for Prognostic. IEEE 4th International Conference on Intelligent Systems Design and Applications (ISDA 2004), Budapest, Hungary, August 26-28, 2004.

Function	Element	Failure Mode	Effects	Causes
to transform pressure to Q_i	VALVE V	Remains closed	$Q_i=0$	No energy from (AD) Valve is down (state 4)
		Remains open	$Q_i>0$	No energy from (AD) Valve is down (state 3)
		The water flow rate is biased	Q_i different from the desired Q_i	Valve is down (state 2)
to stock water Q_i to H	TANK	Leak of water	Water loss in the environment	Tank is down (state 2) Fissure
to transform H to Q_o	WATER PIPE	Clogged	$Q_o=0$	Pipe is down (state 3)
		Restricted	$Q_o <$ desired Q_o	Pipe is down (state 2)
to heat water from T_i to T	HEATING RESISTOR	Maximum level of heat	$T >$ desired T	Heating resistor is down (state 2)
		No heating	$T=T_i = 20^\circ\text{C}$	No energy from (AD) Heating resistor is down (state 4)
		Heating power loss	$T <$ desired T	Heating resistor is down (state 3)
to measure H	H SENSOR	Biased measure	Q_o is different from the real Q_o	H sensor is down (state 2)
		No measure	Impossibility to control Q_o	No energy from (AD) H sensor is down (state 3)
to measure T	T SENSOR	Biased measure	T is different from the real T	T sensor is down (state 2)
		No measure	Impossibility to control P	No energy from (AD) T sensor is down (state 3)
to control V and P	COMPUTER	Control loss	Deviation of T and H	No energy from (AD) Computer is down (state 2)



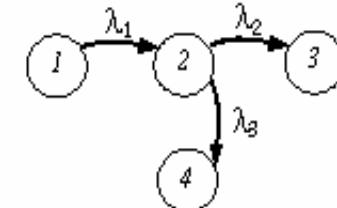
Action
to emplace

HEATING RESISTOR reliability MC model.



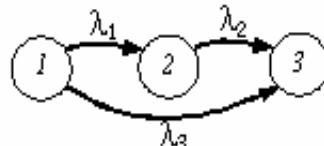
MTTF ₁ =10 000 h	$\lambda_1=1 \cdot 10^{-4}$
MTTF ₂ =500 h	$\lambda_2=20 \cdot 10^{-4}$
MTTF ₃ =7 000 h	$\lambda_3=1.43 \cdot 10^{-4}$
MTTF ₄ =2 000 h	$\lambda_4=5 \cdot 10^{-4}$
MTTF ₅ =15 000 h	$\lambda_5=0.66 \cdot 10^{-4}$

VALVE V reliability MC model.



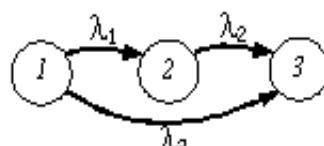
MTTF ₁ =5 000 h	$\lambda_1=2 \cdot 10^{-4}$
MTTF ₂ =3 000 h	$\lambda_2=3.3 \cdot 10^{-4}$
MTTF ₃ =6 000 h	$\lambda_3=1.66 \cdot 10^{-4}$

H SENSOR reliability MC model.



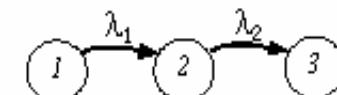
MTTF ₁ =5 000 h	$\lambda_1=2 \cdot 10^{-4}$
MTTF ₂ =3 000 h	$\lambda_2=3.3 \cdot 10^{-4}$
MTTF ₃ =45 000 h	$\lambda_3=0.22 \cdot 10^{-4}$

T SENSOR reliability MC model.



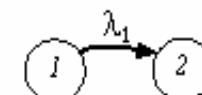
MTTF ₁ =5 000 h	$\lambda_1=2 \cdot 10^{-4}$
MTTF ₂ =3 000 h	$\lambda_2=3.3 \cdot 10^{-4}$
MTTF ₃ =45 000 h	$\lambda_3=0.22 \cdot 10^{-4}$

WATER PIPE reliability MC model.



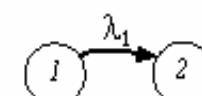
MTTF ₁ =5 000 h	$\lambda_1=2 \cdot 10^{-4}$
MTTF ₂ =10 000 h	$\lambda_2=1 \cdot 10^{-4}$

TANK reliability MC model.



MTTF ₁ =40 000 h	$\lambda_1=0.25 \cdot 10^{-4}$
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COMPUTER reliability MC model.

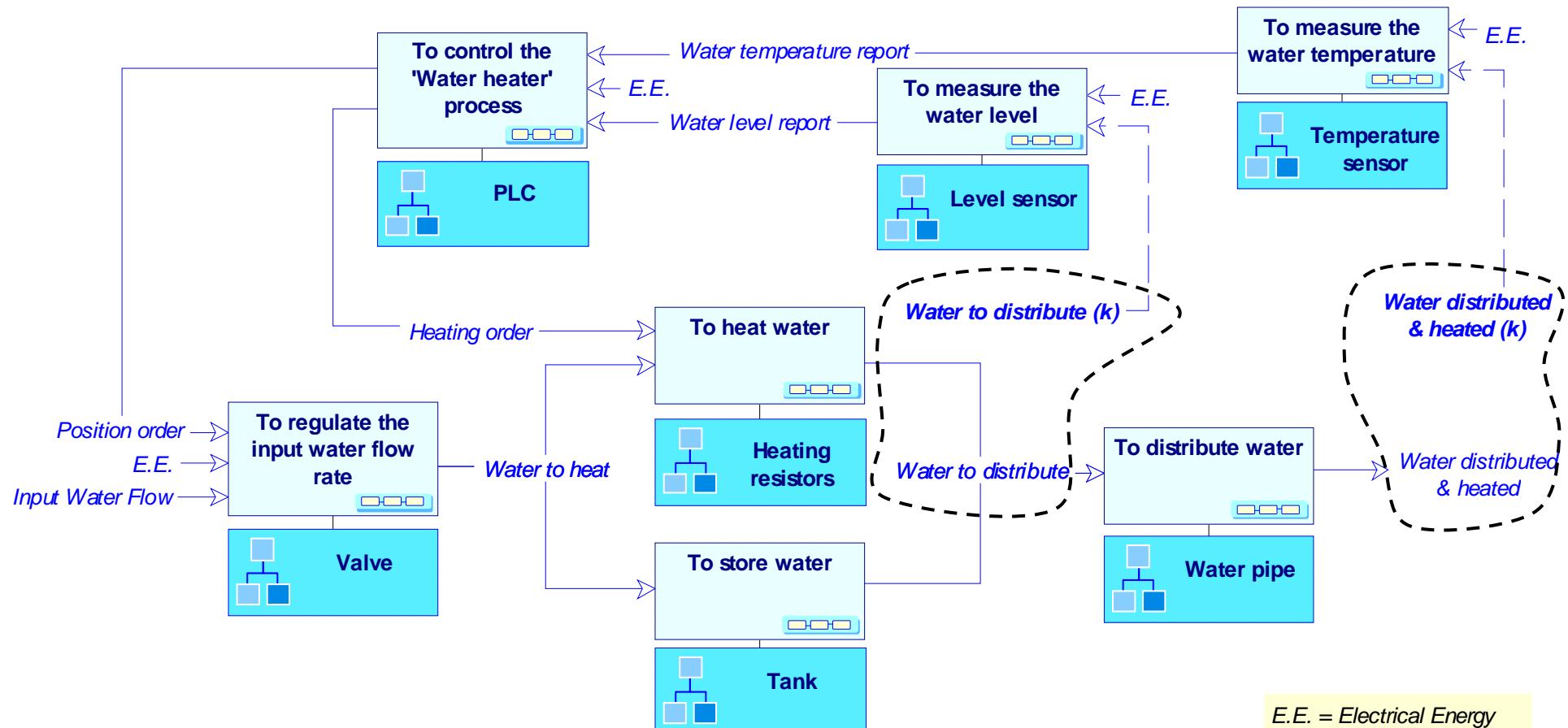


MTTF ₁ =8 000 h	$\lambda_1=1.25 \cdot 10^{-4}$
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Application 2 in Reliability

Dynamic Bayesian Network - Factorized MC model

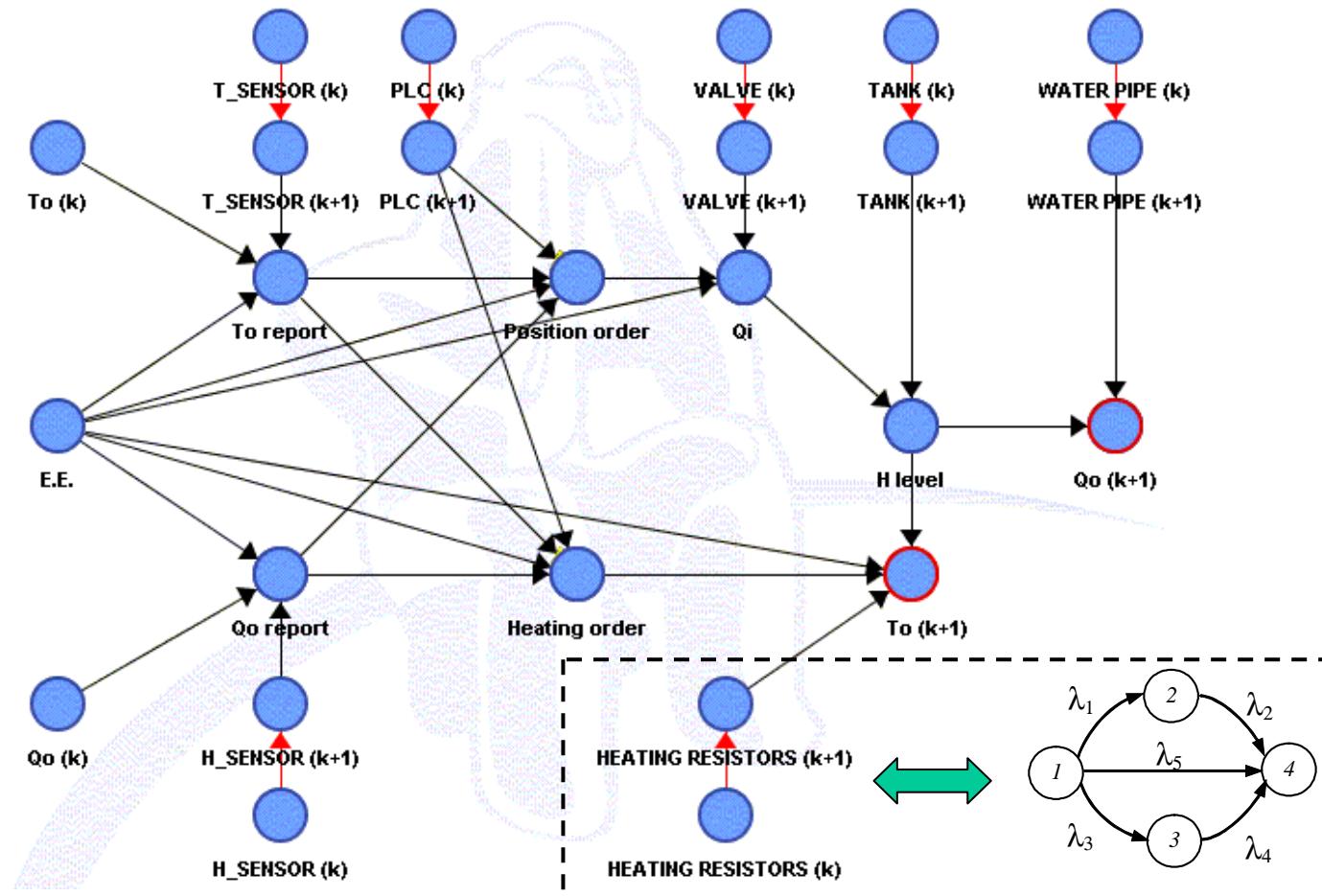
Water heater (Process model)



Application 2 in Reliability

Dynamic Bayesian Network - Factorized MC model

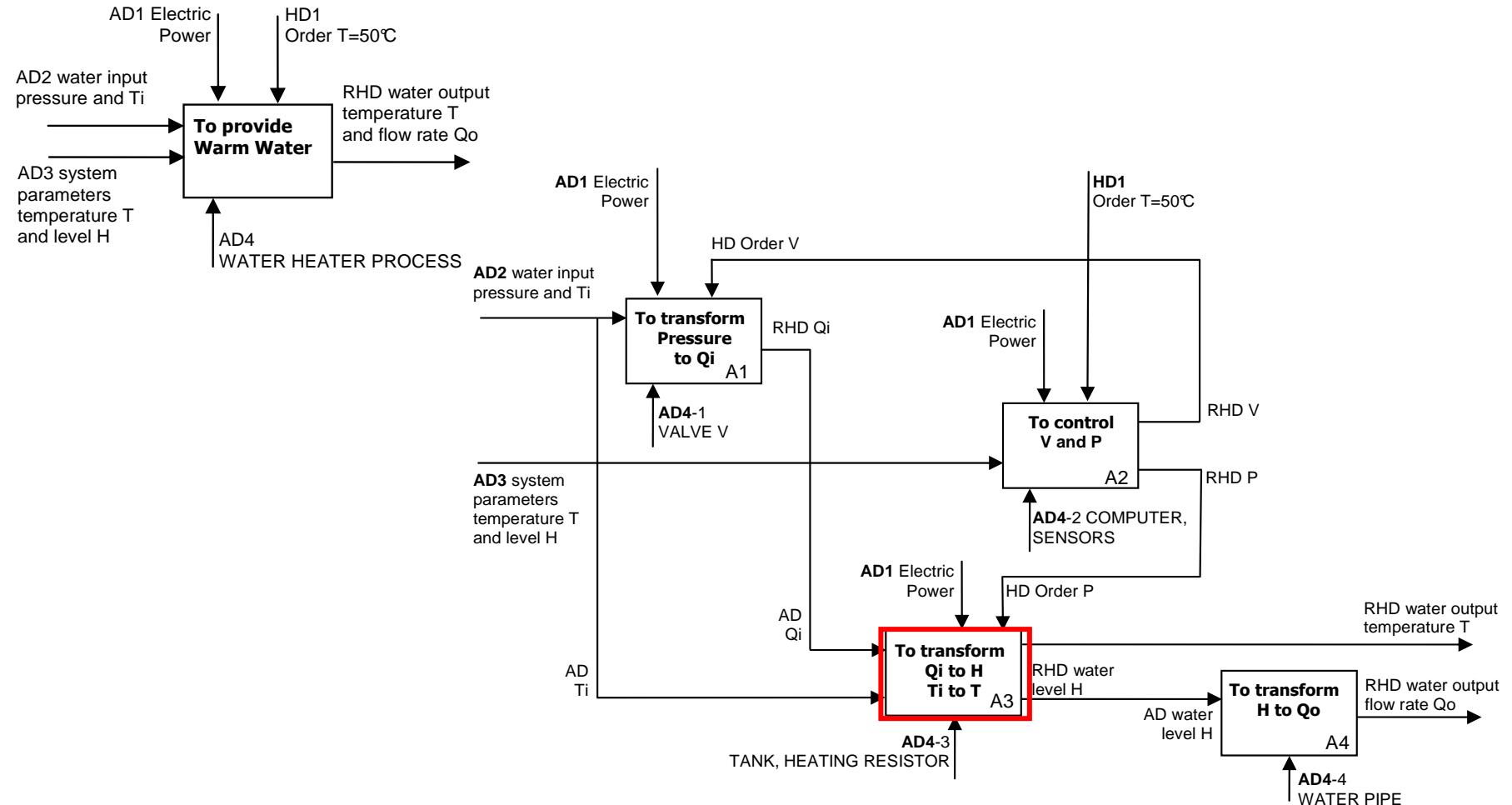
Water heater (Probabilistic model - DBN)



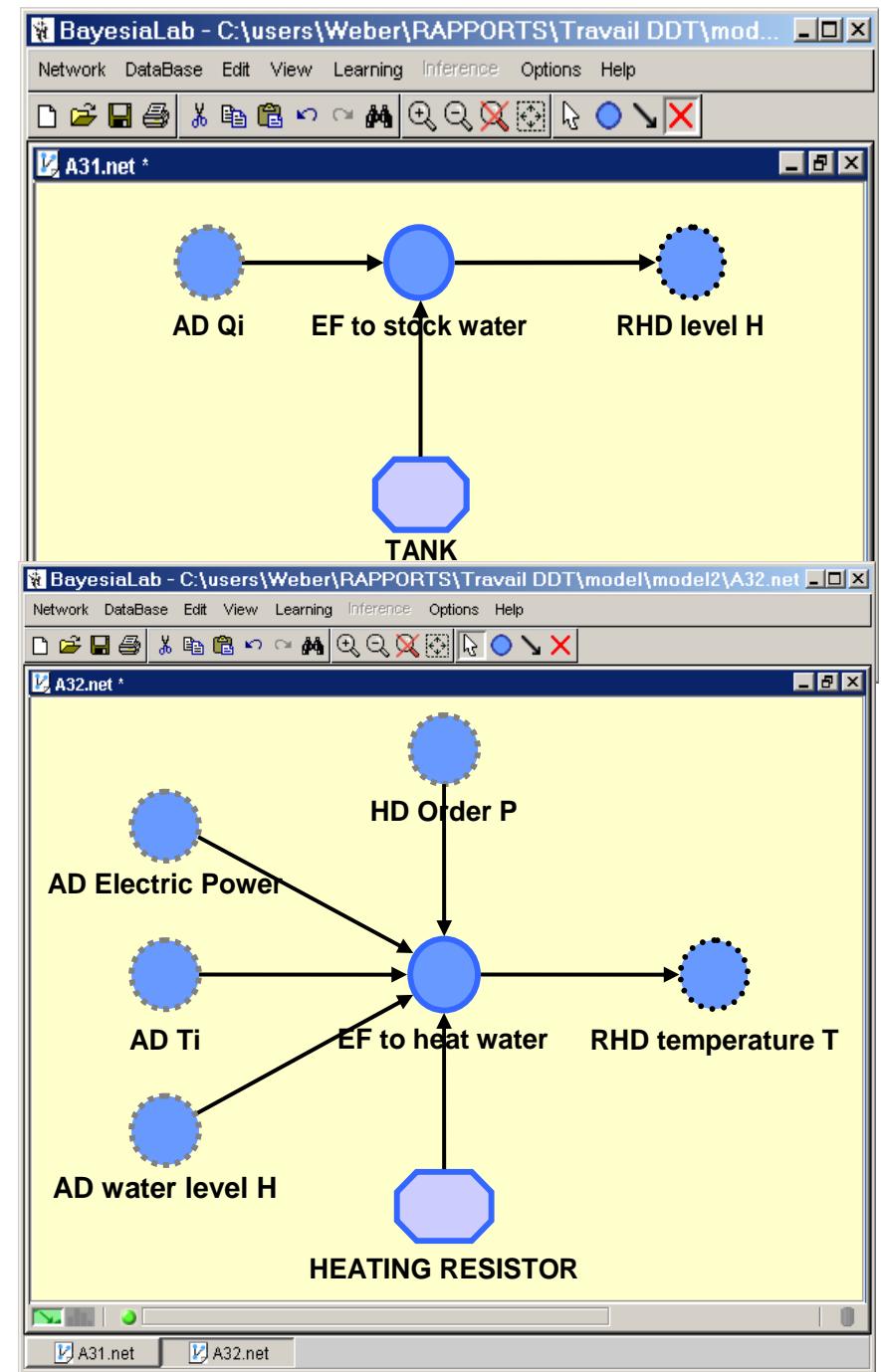
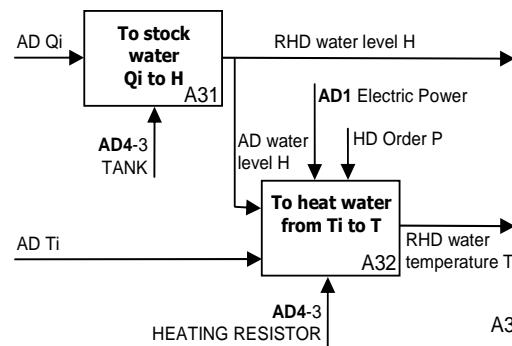
Application 2 in Reliability

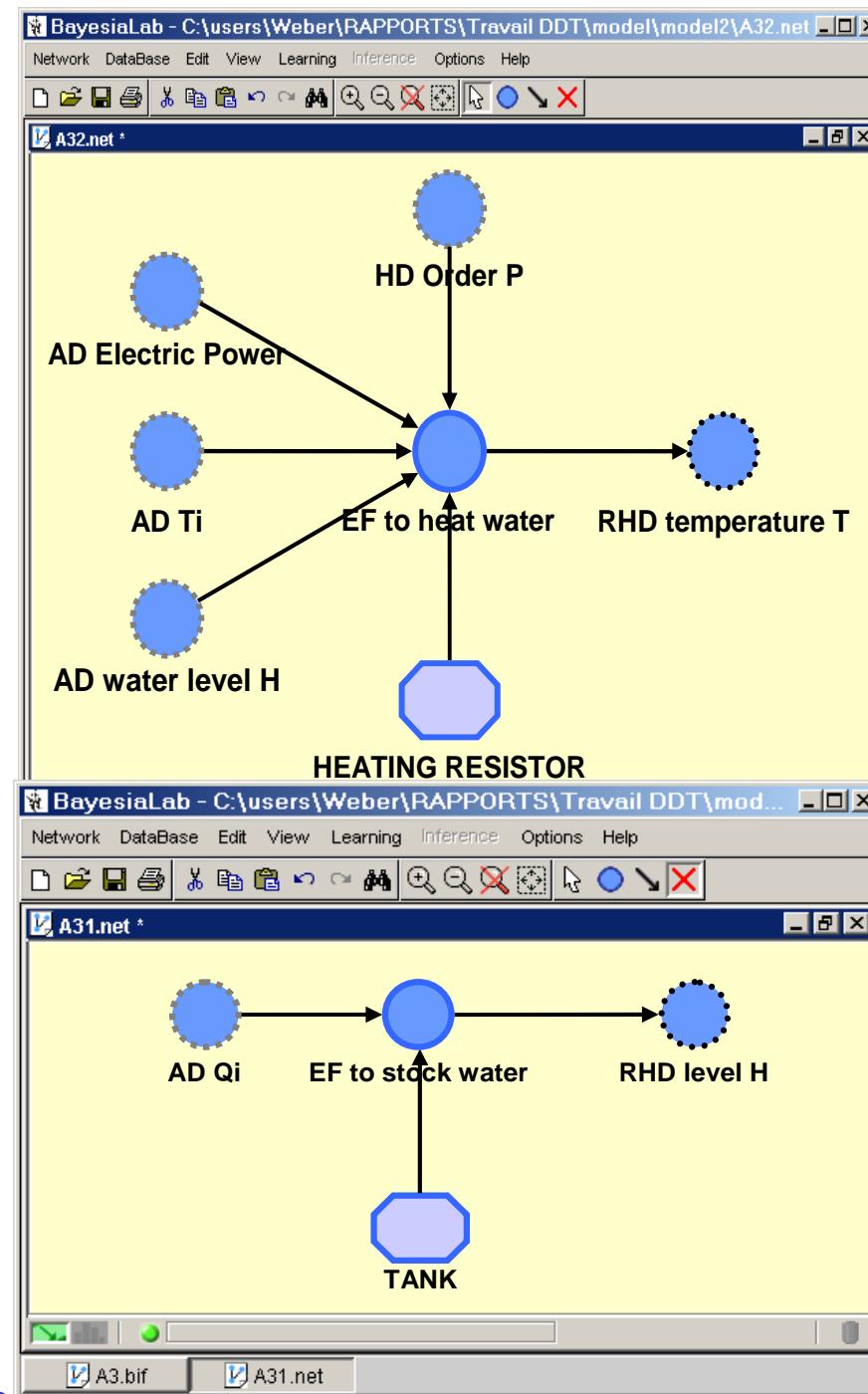
Dynamic Bayesian Network - Factorized MC model

Water heater (SADT model and OODBN model)

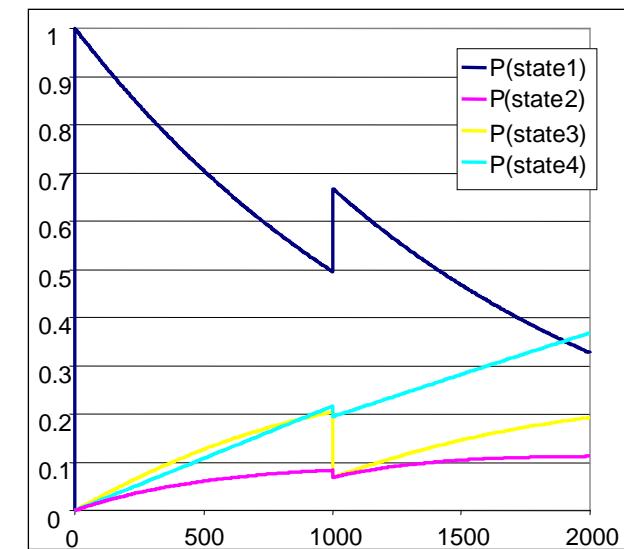


Application 2 in Reliability

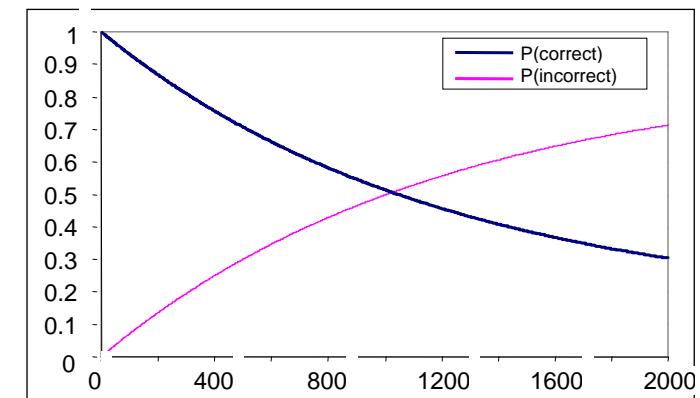




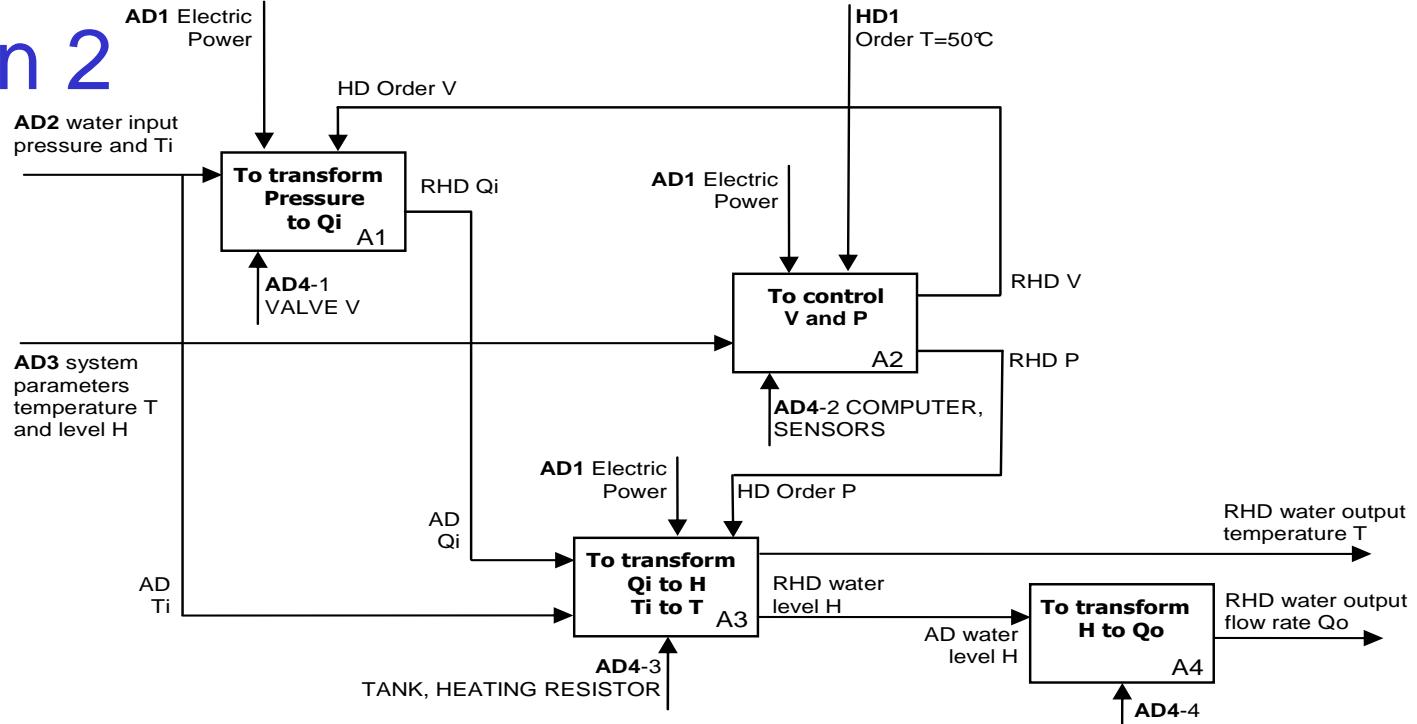
EF to heatwater(k)



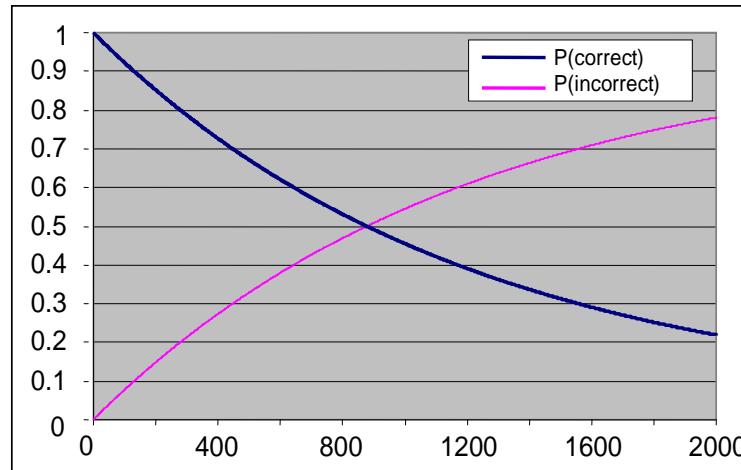
RHD water level H



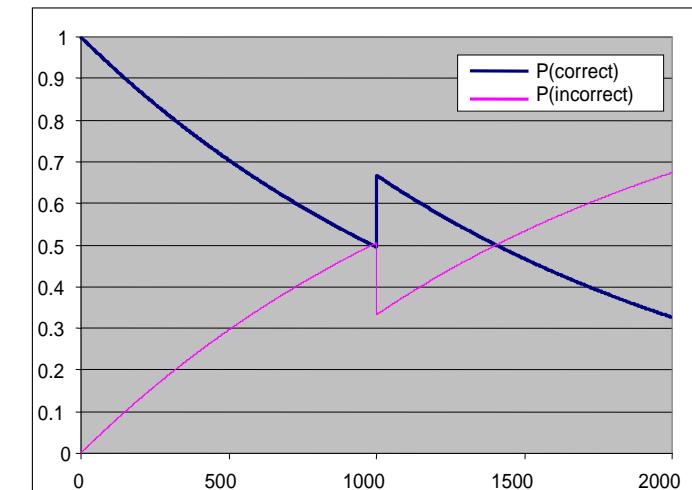
Application 2



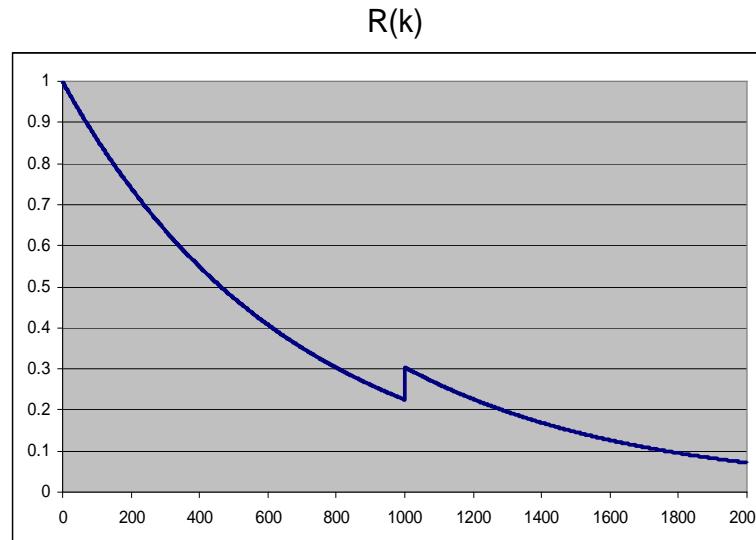
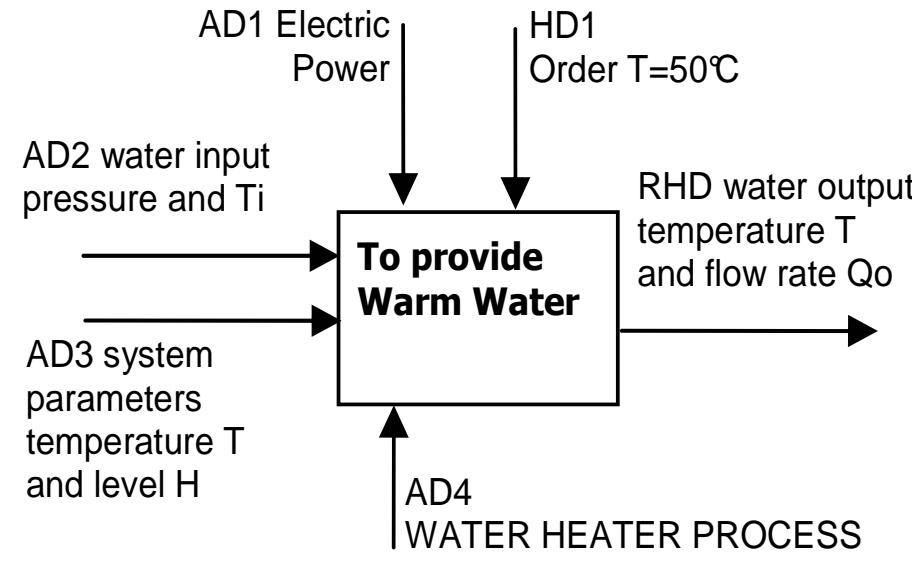
RHD water output flow rate Q_o (k)



RHD water output temperature T (k)



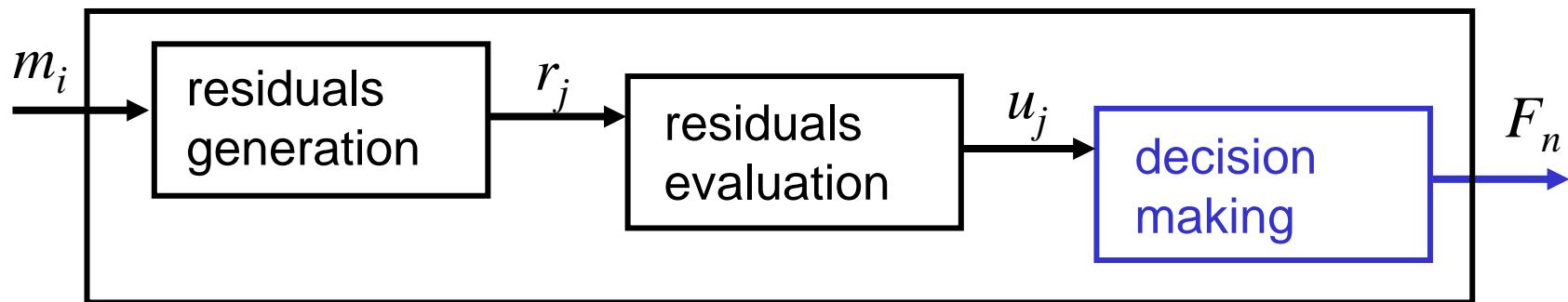
Application 2 in Reliability



Dynamic Bayesian Networks in Diagnosis & Reliability Analysis

Dynamic Bayesian Networks in System Diagnosis

The diagnosis is composed of three stages:



- Classically, decision making is realized by an elementary logic

Nevertheless, in this case, when **multiple faults, false alarms and missing detections** occur, the faults can not be isolated

- In the spirit of (Isermann, 1994), fault isolation performance can increase through the integration of other knowledge in the diagnosis

Problem statement

Increasing effectiveness of model-based fault diagnosis with the integration of reliability analysis

Computed by means of stochastic process model, reliability analysis define ***the a priori behavior of the probabilities distribution*** over the functioning and mal-functioning states of the system

- ⚠ In fault diagnosis the decision is then based on the fusion of information coming from residuals evaluation and ***a priori behavior*** computed by a **probabilistic model of reliability**
- ⚠ The **probabilistic model of reliability** must take into account the observations on the system, **this is new in reliability analysis!?**
- ➔ **Bayesian Networks (BN)** are investigated to compute the decision => BN are able to model dynamic and probabilistic problems

FDI decision making

The fault is the cause of the residual deviation

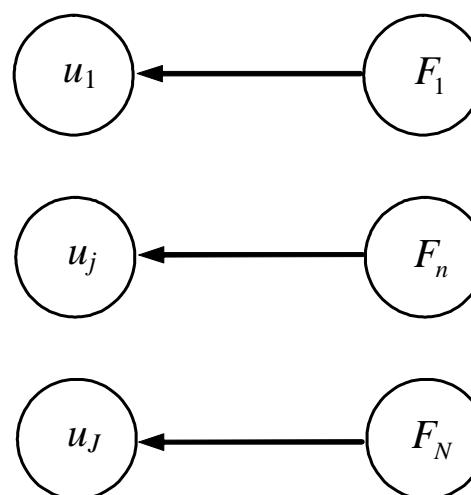
A **fault** is modelled as a random variable F_n defined over two states

{not Occurred, Occurred}

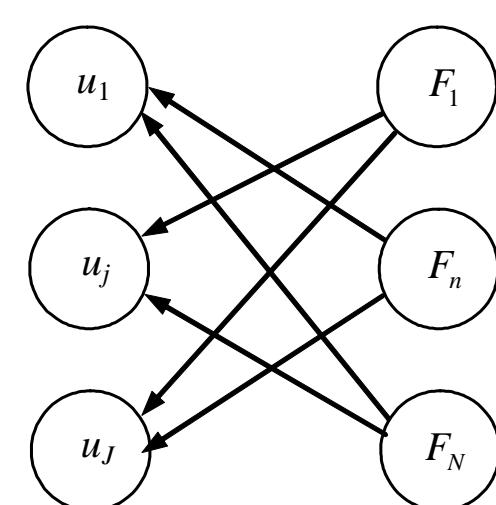
A **symptom** is represented also as u_j defined over the states

{not detected, detected}

$D(n,j)$	F_1	F_n	F_N
u_1	1	0	0
u_j	0	1	0
u_J	0	0	1



$D(n,j)$	F_1	F_n	F_N
u_1	0	1	1
u_j	1	0	1
u_J	1	1	0

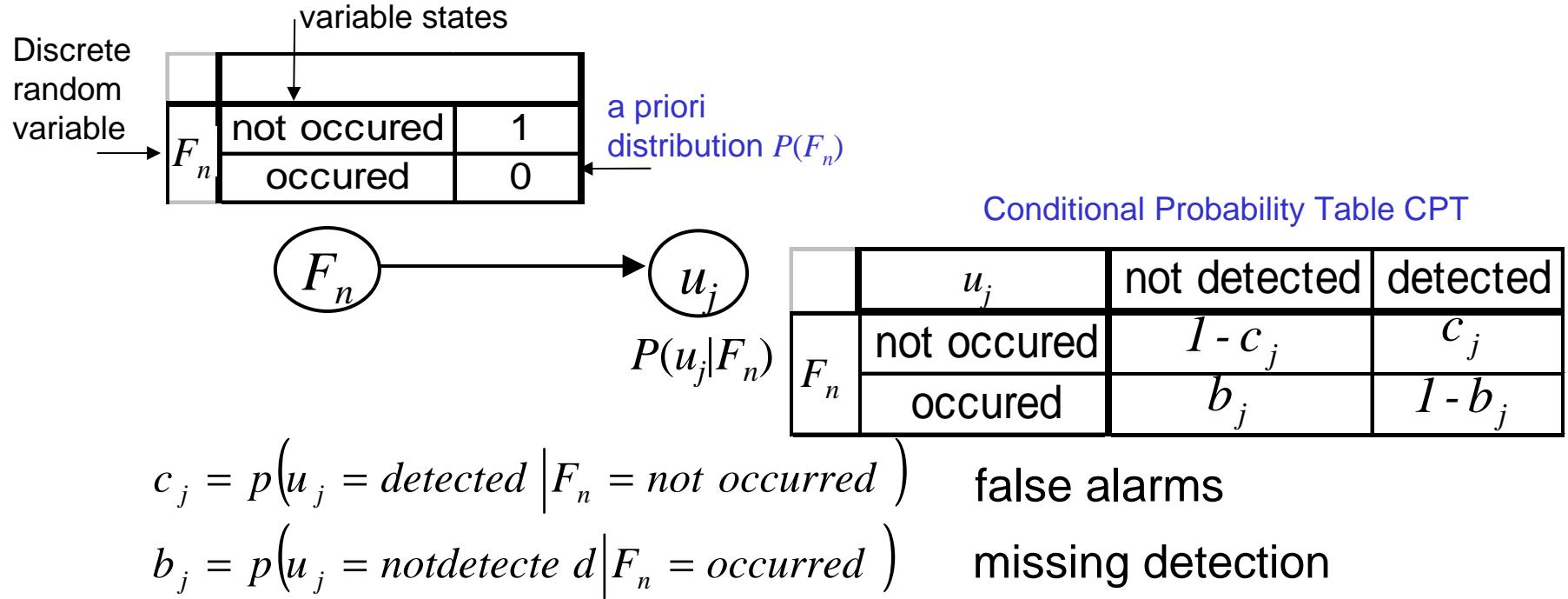


The BN Structure is defined directly by the incidence matrix D

WEBER P., THEILLIOL D., AUBRUN C., EVSUKOFF A.G., Increasing effectiveness of model-based fault diagnosis: A Dynamic Bayesian Network design for decision making. 6th IFAC Symposium on Fault Detection, Supervision and Safety of Technical Processes, Beijing, P.R. China (30/08/2006), pp. 109-114.

FDI decision making

Bayesian Network Parameters



The Bayes theorem is applied in the BN inference to compute the probability that a fault occurred according to the states of the symptoms u_j

$$p(F_n|u_j) = \frac{p(F_n)p(u_j|F_n)}{p(u_j)}$$

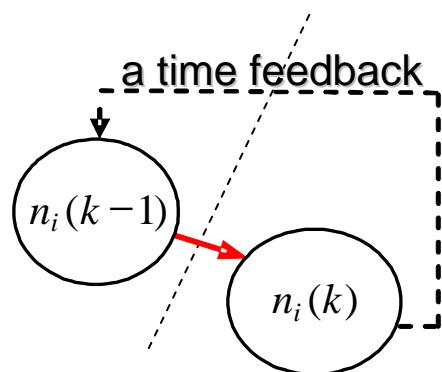
a priori distribution on Fault

Conditional Probability Table parameters

Online residual evaluation

a priori Reliability Model

Dynamic Bayesian Network Parameters



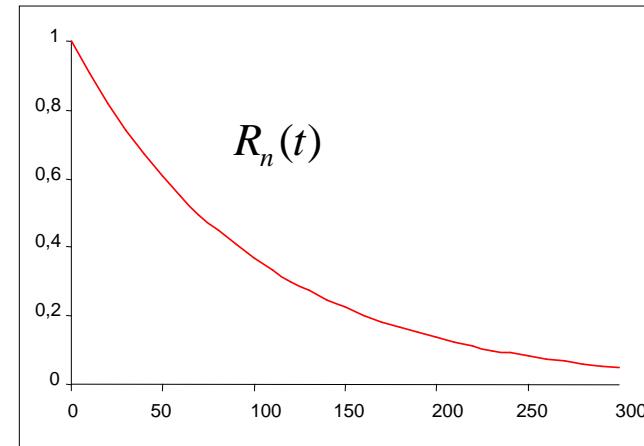
inter-time slices CPT

CPT	$n_i(k)$	
$n_i(k-1)$	<i>up</i>	<i>down</i>
<i>up</i>	$1-p_{12}$	p_{12}
<i>down</i>	0	1

Starting from an observed situation at time $k=0$, the probability distribution over the states is computed (simulation) **using successive inferences**

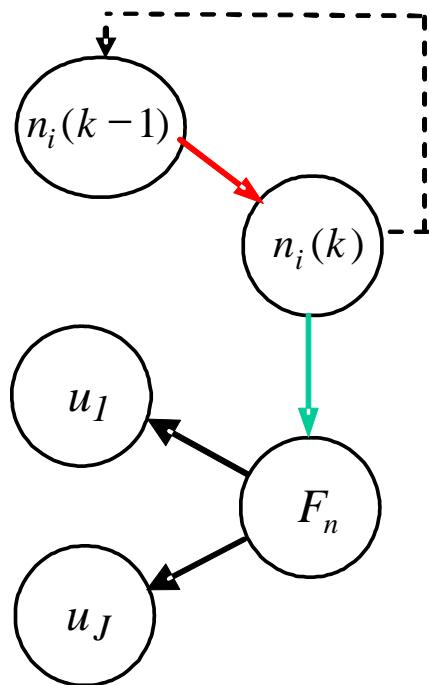
- the *inter-time slices CPT* are equivalent to Markov Chain model of each component

a priori Reliability of the component n



Fusion

The *a priori* Reliability of the component n is used to initialise the *a priori* distribution on the fault F_n states



Hypothesis to simplify the model in this first work:

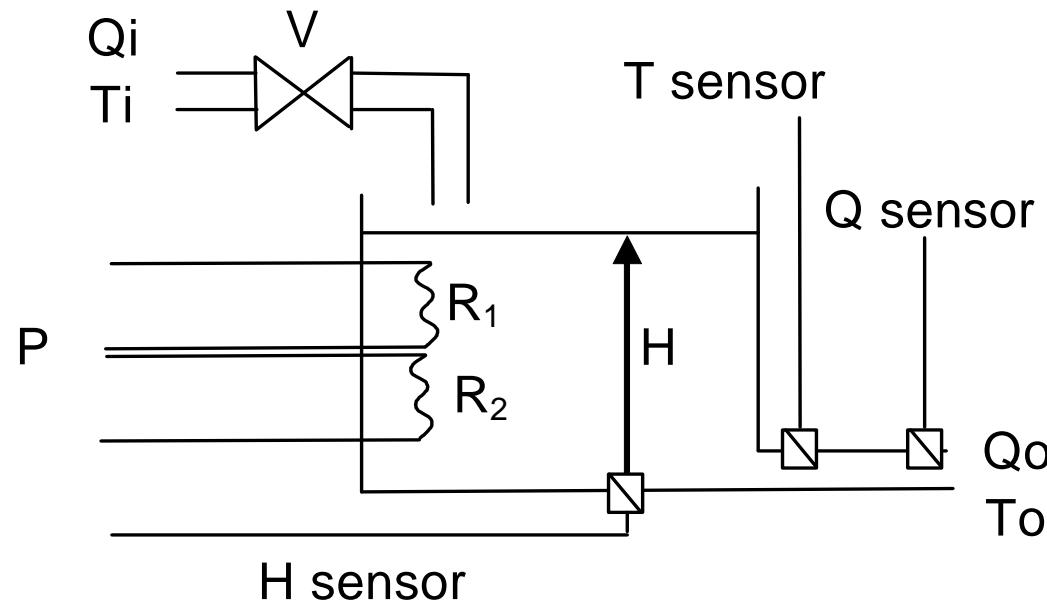
- Only one component contribute to the *a priori* distribution on a fault
- A component reliability is independent from the others components states

	F_n	not occurred	occurred
$n_i(k)$	up	1	0
	down	0	1

WEBER P., THEILLIOL D., AUBRUN C., EVSUKOFF A.G., Increasing effectiveness of model-based fault diagnosis: A Dynamic Bayesian Network design for decision making. 6th IFAC Symposium on Fault Detection, Supervision and Safety of Technical Processes, Beijing, P.R. China (30/08/2006), pp. 109-114.

Application in Diagnosis

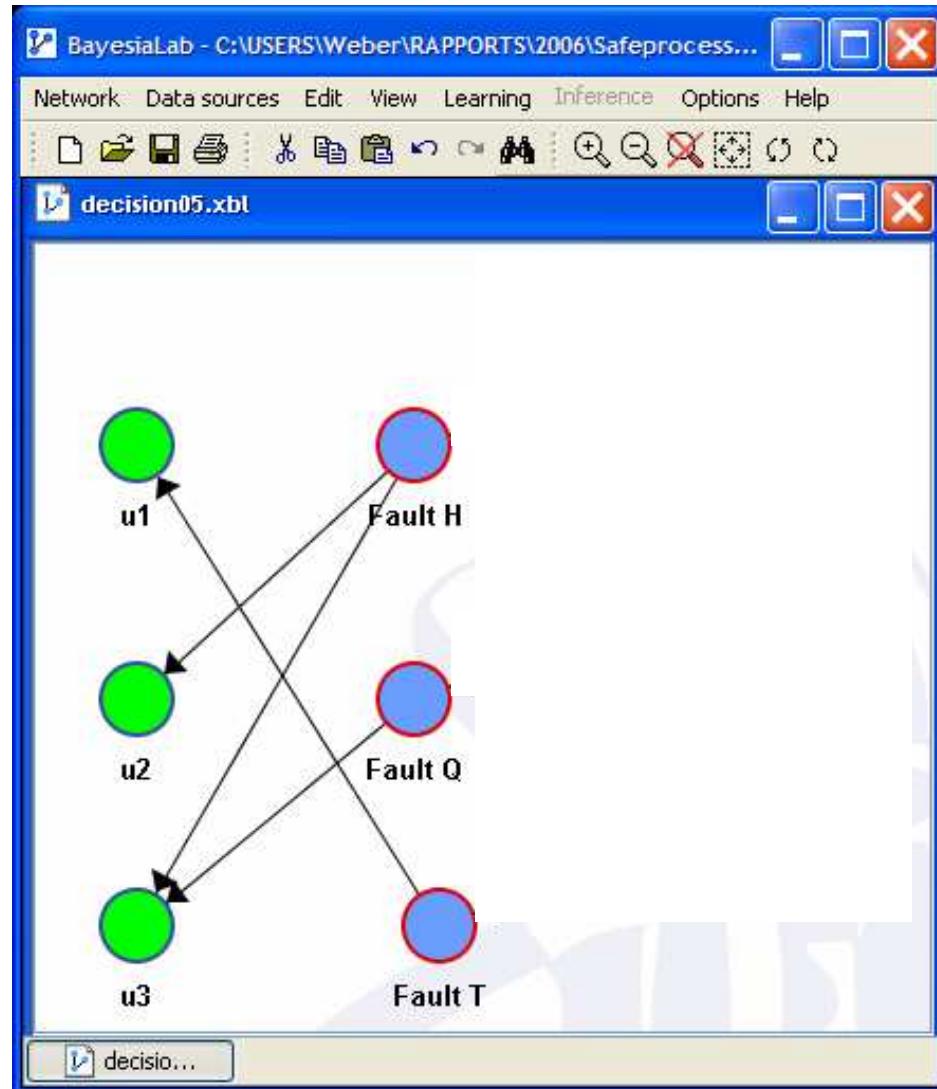
Water heater (Physical process)



The goal of the process is to assure a constant water flow rate Q_o with a given controlled temperature To .

Application in Diagnosis

The decision DBN model



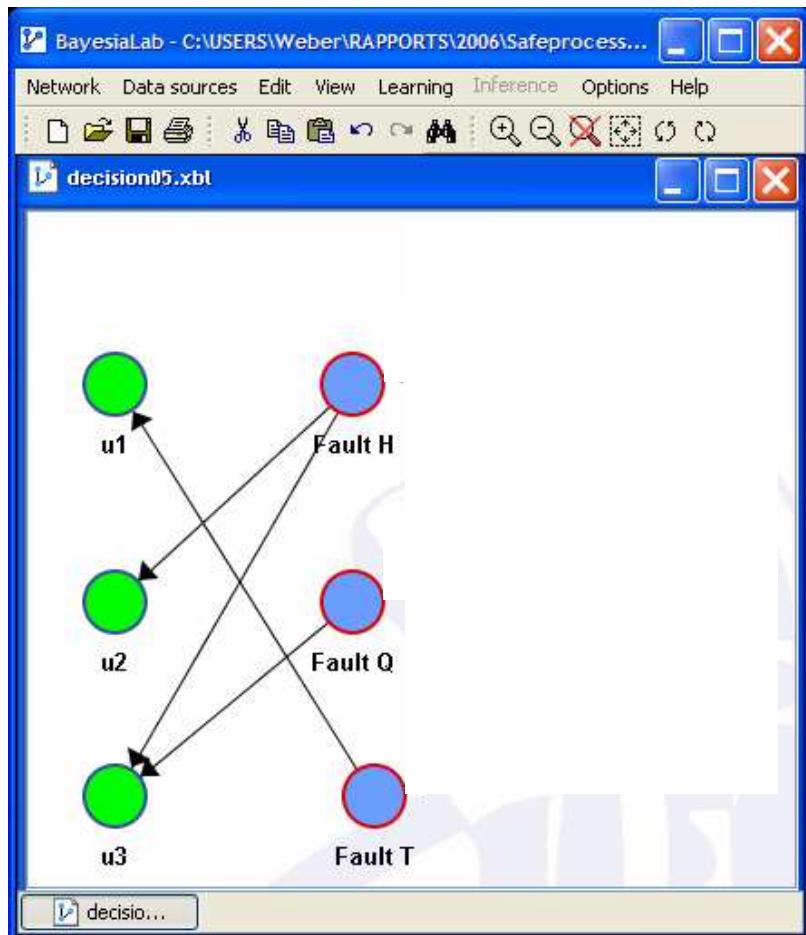
Incidence matrix

	Sensor faults		
	<i>H</i>	<i>Q</i>	<i>T</i>
u_1	0	0	1
u_2	1	0	0
u_3	1	1	0

Application in Diagnosis

The decision DBN model

For all faults of the system, it is assumed that the probability of miss detection is fixed to 0.02 and the probability of false alarms is fixed to 0.05

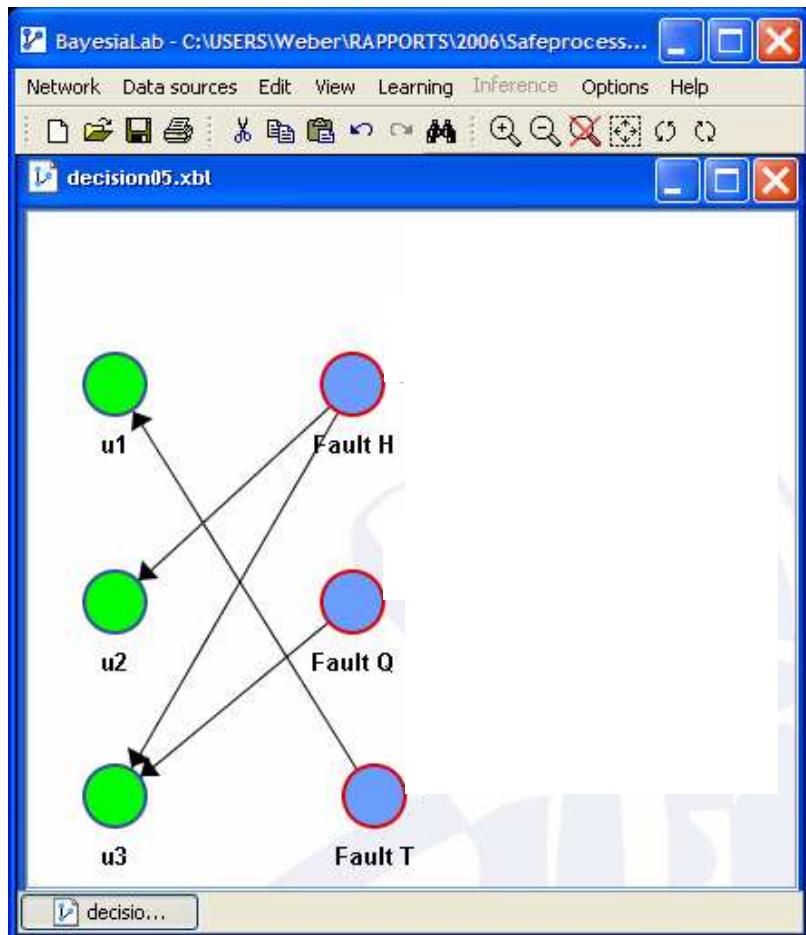


u1		
Fault T	<i>not detected</i>	<i>detected</i>
<i>not occurred</i>	95	5
<i>occurred</i>	2	98

Application in Diagnosis

The decision DBN model

For all faults of the system, it is assumed that the probability of miss detection is fixed to 0.02 and the probability of false alarms is fixed to 0.05



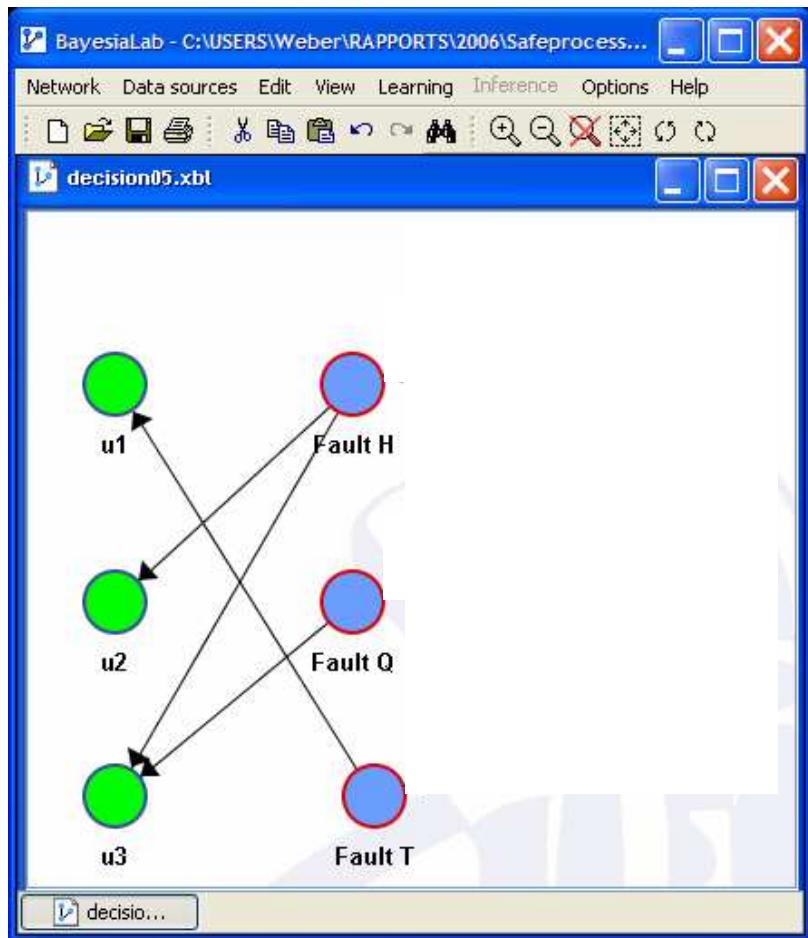
u1		
Fault T	<i>not detected</i>	<i>detected</i>
<i>not occurred</i>	95	5
<i>occurred</i>	2	98

u2		
Fault Q	<i>not detected</i>	<i>detected</i>
<i>not occurred</i>	95	5
<i>occurred</i>	2	98

Application in Diagnosis

The decision DBN model

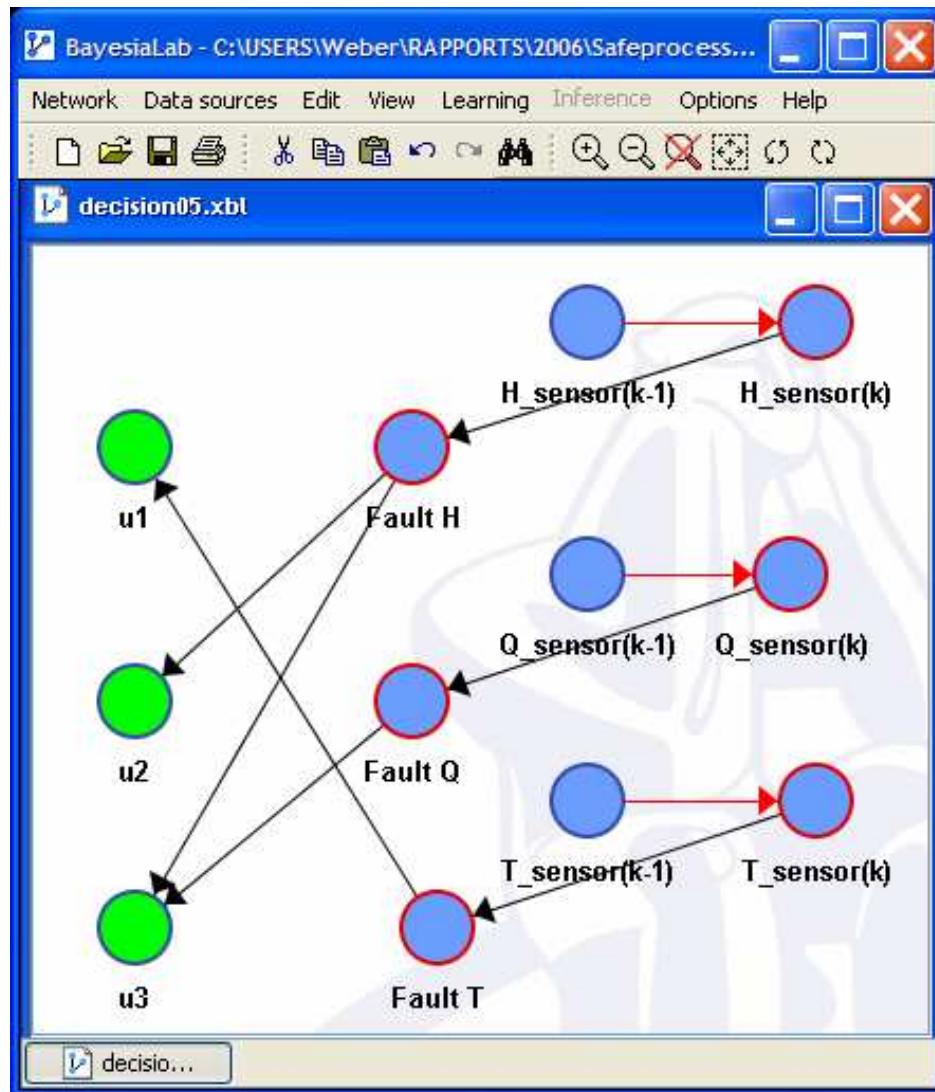
For all faults of the system, it is assumed that the probability of miss detection is fixed to 0.02 and the probability of false alarms is fixed to 0.05



		u1	
Fault T	<i>not detected</i>	<i>detected</i>	
<i>not occurred</i>	95	5	
<i>occurred</i>	2	98	
		u2	
Fault Q	<i>not detected</i>	<i>detected</i>	
<i>not occurred</i>	95	5	
<i>occurred</i>	2	98	
		u3	
Fault H	Fault Q	<i>not detected</i>	<i>detected</i>
<i>not occurred</i>	<i>not occurred</i>	90.25	9.75
	<i>occurred</i>	1.9	98.1
<i>Occurred</i>	<i>not occurred</i>	1.9	98.1
	<i>occurred</i>	0.04	99.96

Application in Diagnosis

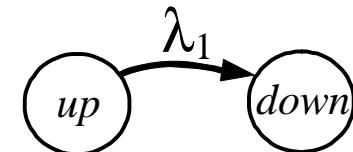
The decision DBN model



Markov Chains

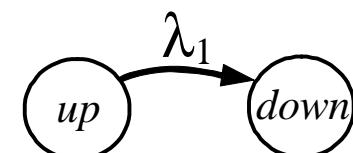
sensor H

$$\lambda_1 = 0.22 \cdot 10^{-4}$$



sensor Q

$$\lambda_1 = 2 \cdot 10^{-4}$$

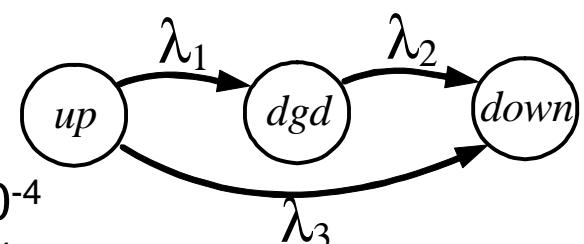


sensor T

$$\lambda_1 = 1.25 \cdot 10^{-4}$$

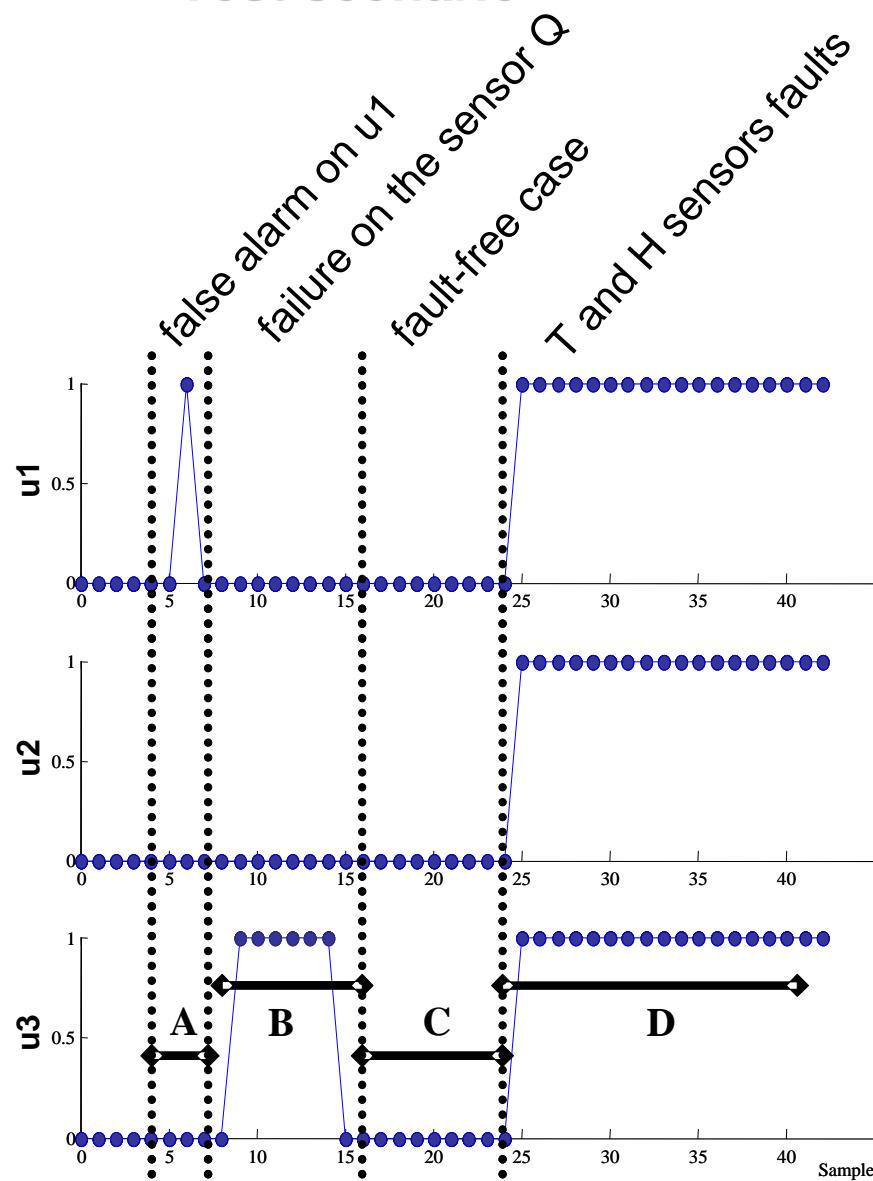
$$\lambda_2 = 3.3 \cdot 10^{-4}$$

$$\lambda_3 = 0.22 \cdot 10^{-4}$$



Application in Diagnosis

Test scenario

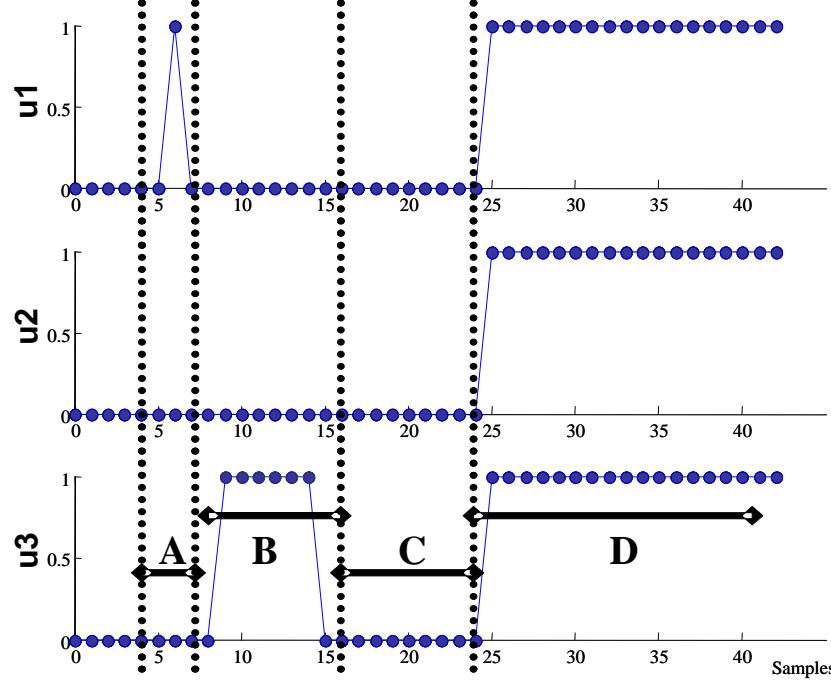


Incidence matrix

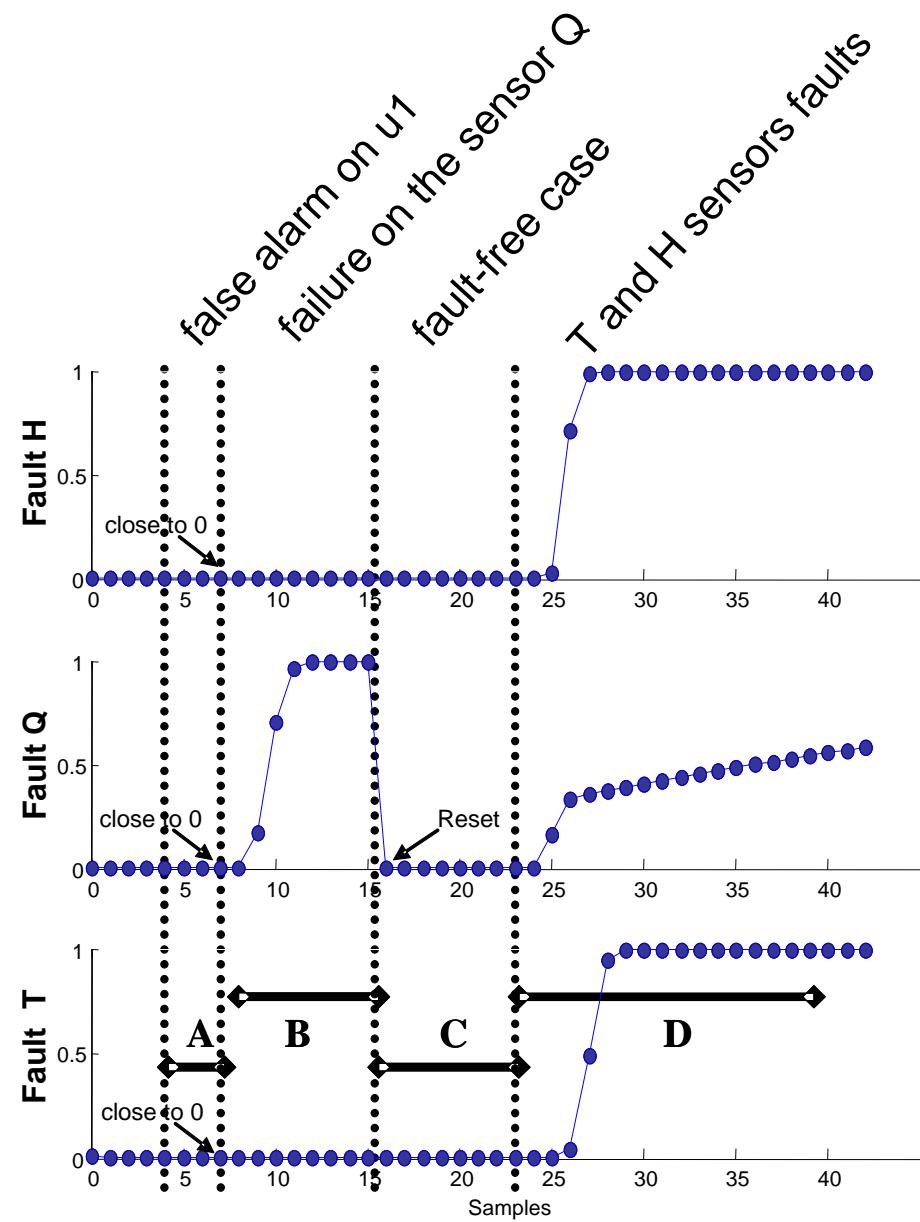
	Sensor faults		
	H	Q	T
u_1	0	0	1
u_2	1	0	0
u_3	1	1	0

Application in Diagnosis

Test scenario



$$P(F_n | u_j) = \frac{P(F_n) P(u_j | F_n)}{P(u_j)}$$
➡



A safety barriers-based approach for the risk analysis of socio-technical systems

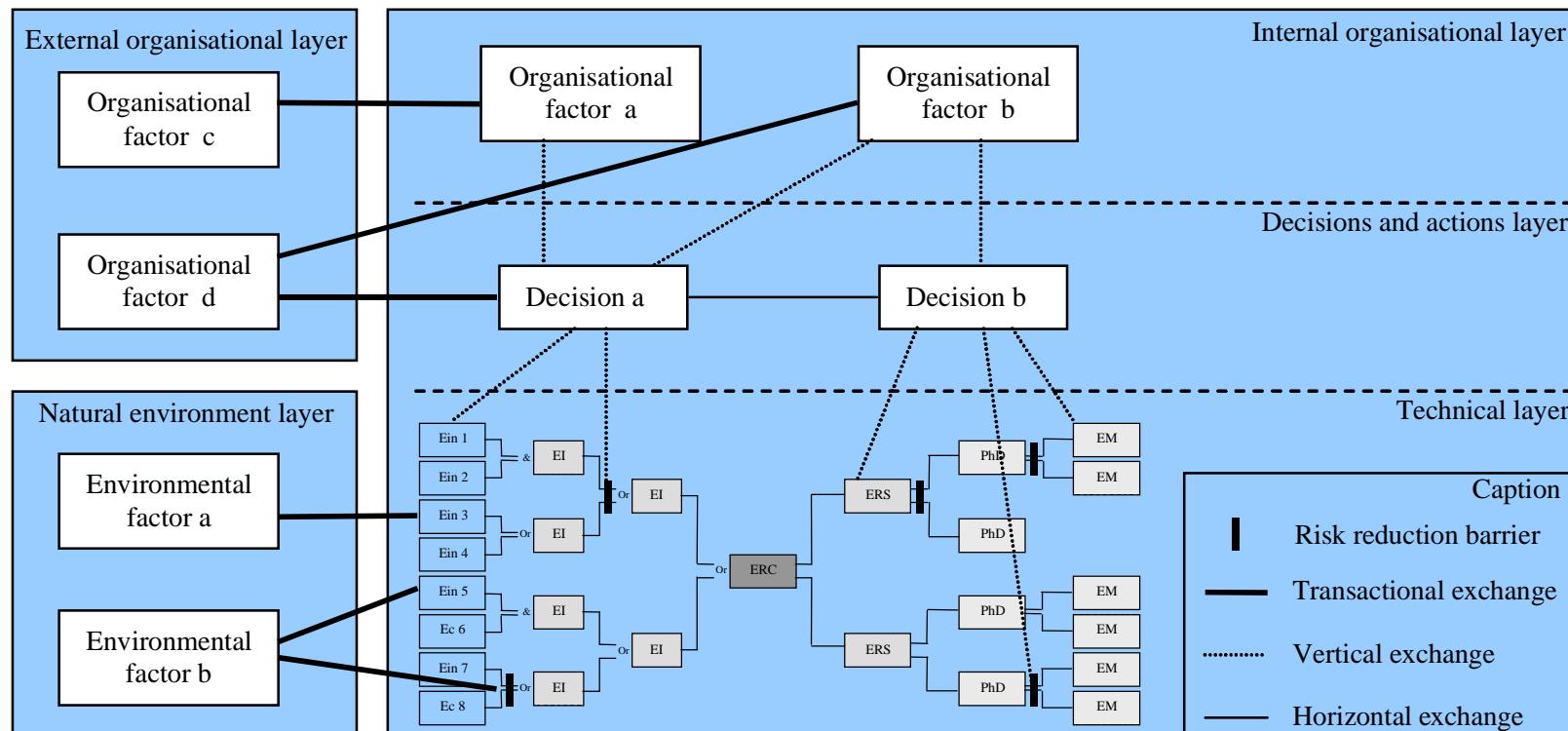
LEGER A., DUVAL C., WEBER P., LEVRAT E., FARRET R., Bayesian Network Modelling the risk analysis of complex socio technical systems. Workshop on Advanced Control and Diagnosis, ACD'2006, Nancy, France (16/11/2006).

DUVAL C., LEGER A., WEBER P., LEVRAT E., IUNG B., FARRET R., Choice of a risk analysis method for complex socio-technical systems. European Safety and Reliability Conference, ESREL 2007, Stavanger, Norvège (25/06/2007).



A global risk analysis model

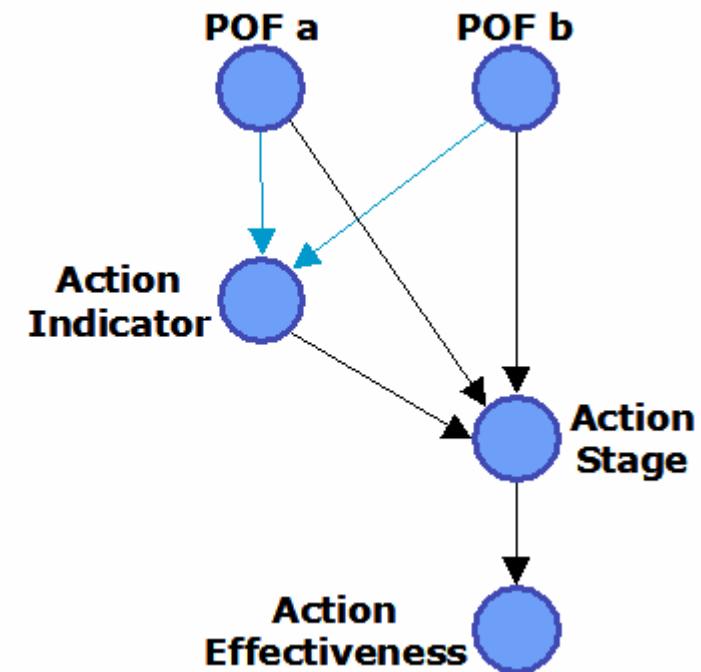
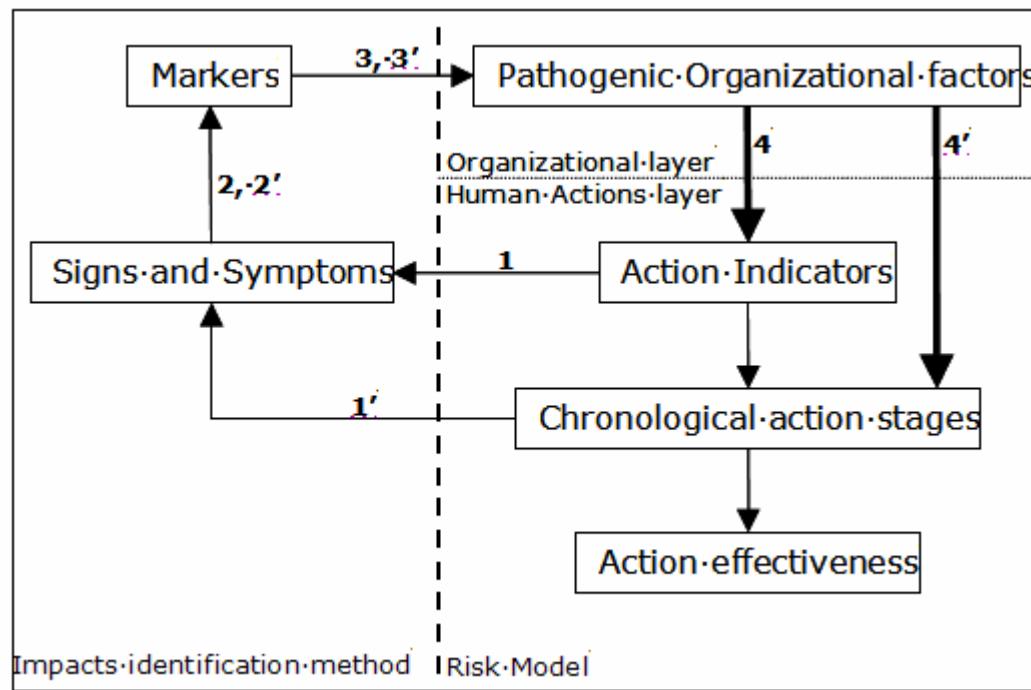
Necessity to establish relations between **different kinds of layers** in the model of the system: **the technical layer (closed system)** and **the human/organisational layer (open system)**



Paté-Cornell M.E.-Murphy D.M., 'Human and management factors in probabilistic risk analysis: the SAM approach and observations from recent applications', Reliability Engineering and System Safety, n°53, pp. 115-126, 1996.

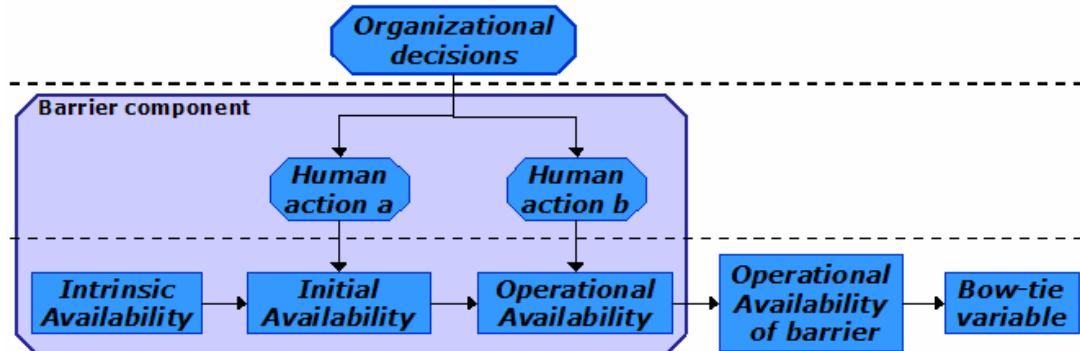
A global risk analysis model

The generic global Bayesian network model structure

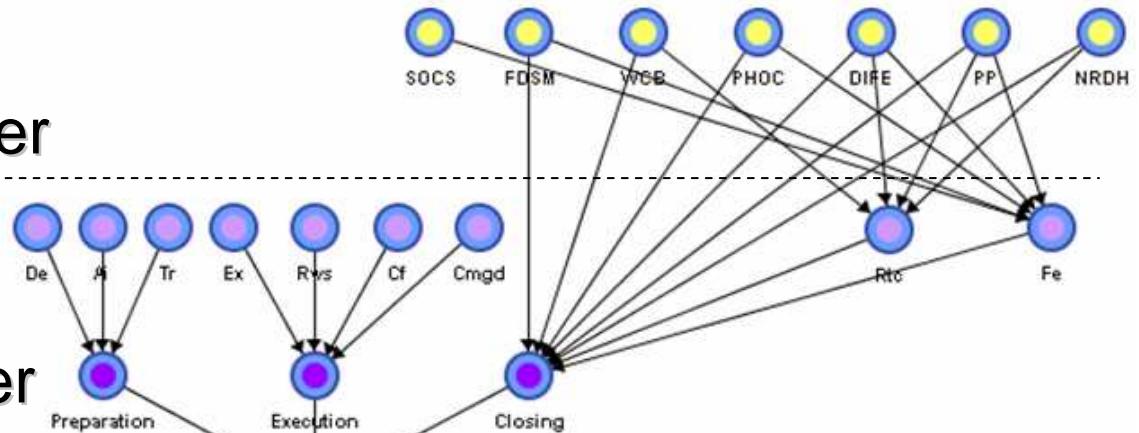


Internal organisational layer

A global risk analysis model



Internal organisational layer



Decisions and actions layer



Decisions and actions layer

Application Pentane storage

Transitional storage tank (product: liquid pentane)

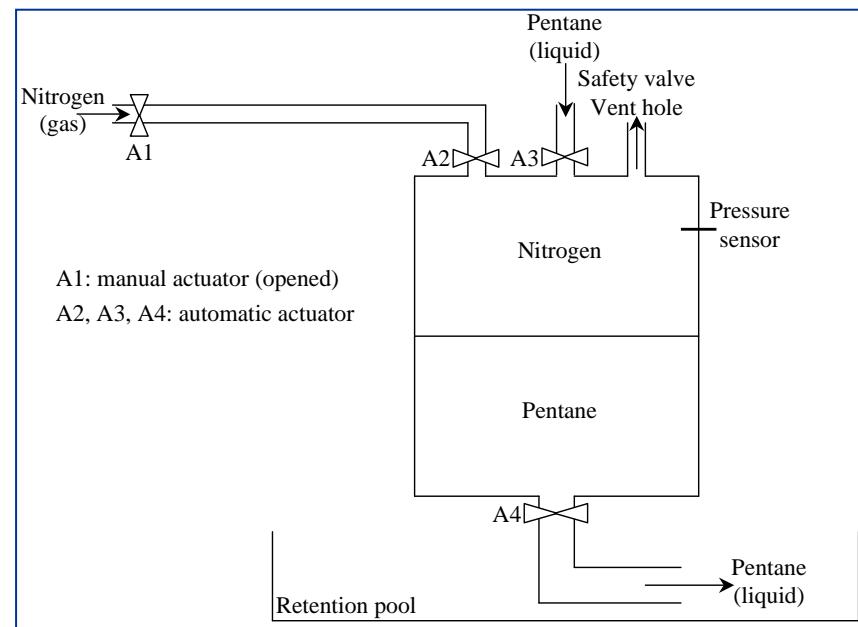
Extremely flammable in air → storage operation made in presence of **gaseous nitrogen** (to prevent any reaction with air)

Safety components:

actuator 1 (A1), vent hole, safety valve, pressure sensor, retention pool

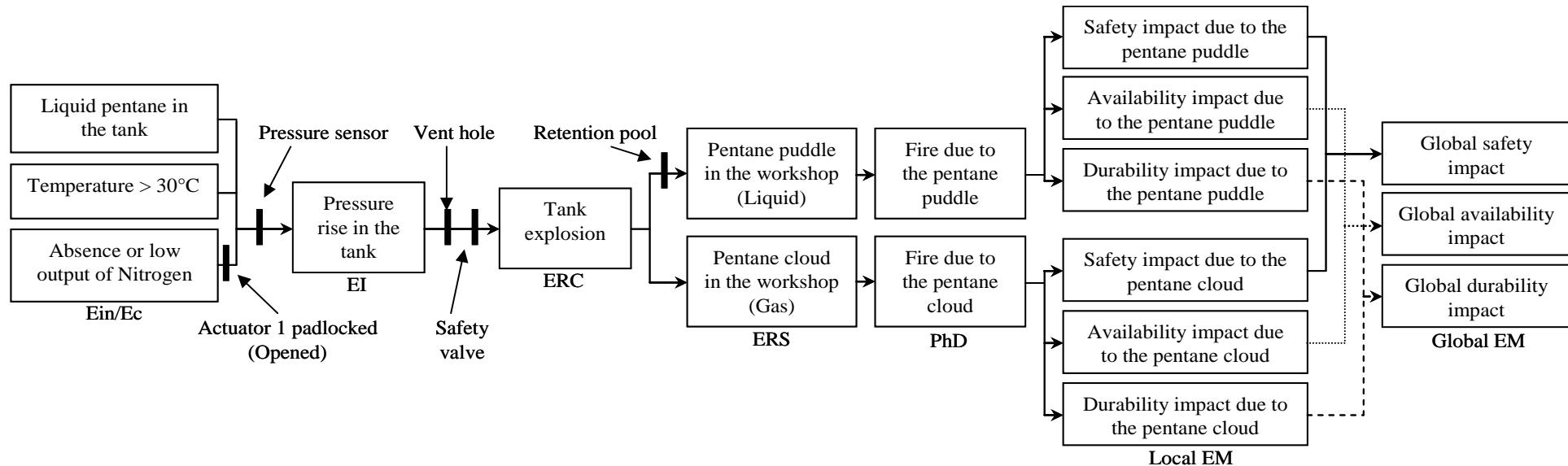
Necessity of a **regular and specific control for the actuator 1 and the safety valve**:

- Actuator 1 has to remain open (to insure an optimal pentane output) → **padlocking and regular follow-up (actions schedule)**,
- Safety valve has to be operational in case of important pressure rises → **regular control of its good operating**.



Studied scenario

Risk of **pressure rise in the tank** → **tank explosion** → **fire in the**

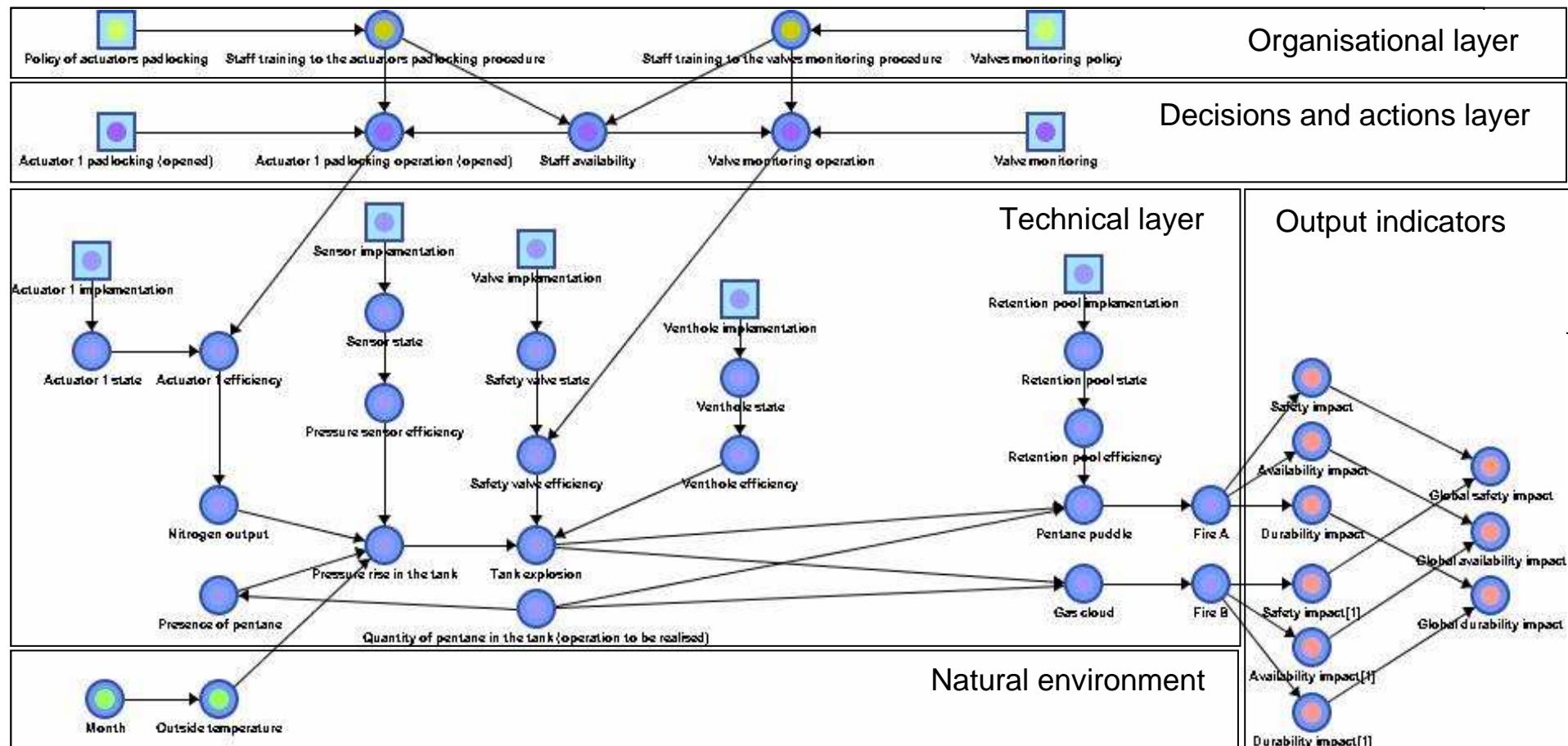


Context:

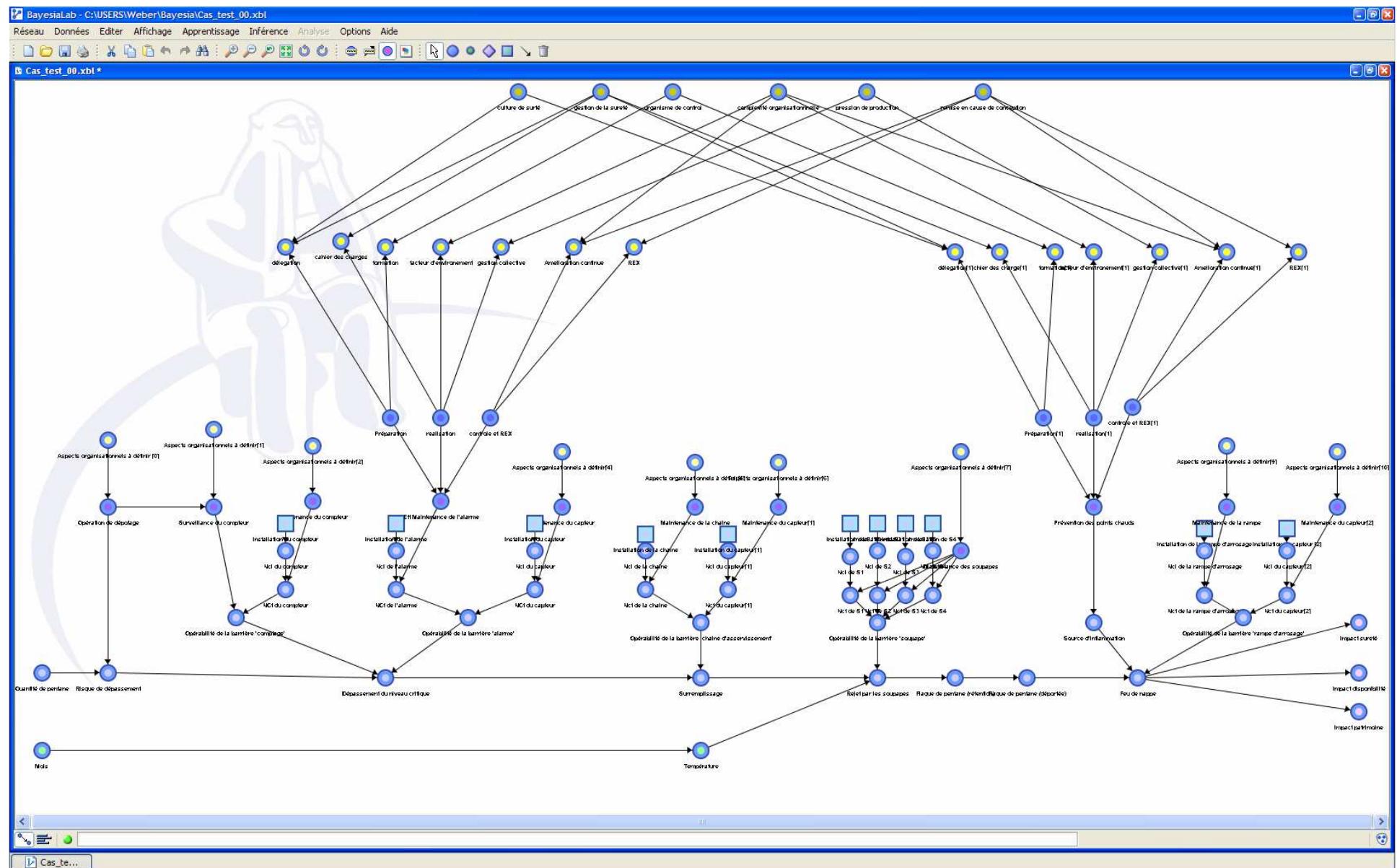
- a **temperature upper than 30°C** (in summer),
- **liquid pentane in the tank**,
- **insufficient quantity of nitrogen in the tank**.

Liquid pentane → **gaseous pentane** → **pressure rise in the tank** → **evacuated by the vent hole and the safety valve** (in a good operating) ...

Bayesian network model



Bayesian network model



Conclusion



Bayesian Networks

- Equivalence between the Bayesian Networks and fault tree...
- Multimodal model
- Acyclic Graph constraint only



Dynamic Bayesian Networks

- Equivalence between the Dynamic Bayesian Networks and MC, ½ MC, MSM, IOHMM
- Thanks to the factorization, DBN leads to a synthetic representation of complex systems



Future works

- MDP application in Maintenance
- Dynamic Evidential Networks in reliability

References of CRAN are available with HAL

<http://hal.archives-ouvertes.fr>

Some ref.

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